

Document Title

512K x 16 Bit x 2 Banks (16-MBIT) SDRAM

Revision History

Revision No	History	Draft Date	Remark
0A	Initial Draft	August 28,2001	
0B	Change toн from 2.5 ns to 2.2 ns	April 15,2002	
0C	Add 60 ball(16M SDRAM) VF-BGA package	September 05,200	03
0D	Add Pb-free package	December 02,200	3
0E	Add speed grade -5ns	July 01,2004	
	Obselte speed grade -8ns		
0F	Revise typo	January 17,2005	

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512K x 16 Bits x 2 Banks (16-MBIT) SYNCHRONOUS DYNAMIC RAM

FEATURES

- · Drive Strength for low capacitive bus loading
- Clock frequency: 200, 166, 143 MHz
- Fully synchronous; all signals referenced to a positive clock edge
- Two banks can be operated simultaneously and independently
- Dual internal bank controlled by A11 (bank select)
- Single 3.3V power supply
- LVTTL interface
- Programmable burst length
 - (1, 2, 4, 8, full page)
- Programmable burst sequence: Sequential/Interleave
- · Auto refresh, self refresh
- 4096 refresh cycles every 64 ms
- · Random column address every clock cycle
- Programmable CAS latency (2, 3 clocks)
- Burst read/write and burst read/single write operations capability
- Burst termination by burst stop and precharge command
- Byte controlled by LDQM and UDQM
- Package 400mil 50-pin TSOP-2 and 60ball(16M) VF-BGA
- Pb(lead)-free package is available

DESCRIPTION

ICSI's 16Mb Synchronous DRAM IC42S16101 is organized as a 524,288-word x 16-bit x 2-bank for improved performance. The synchronous DRAMs achieve high-speed data transfer using pipeline architecture. All inputs and outputs signals refer to the rising edge of the clock input.

PIN CONFIGURATIONS 50-Pin TSOP-2

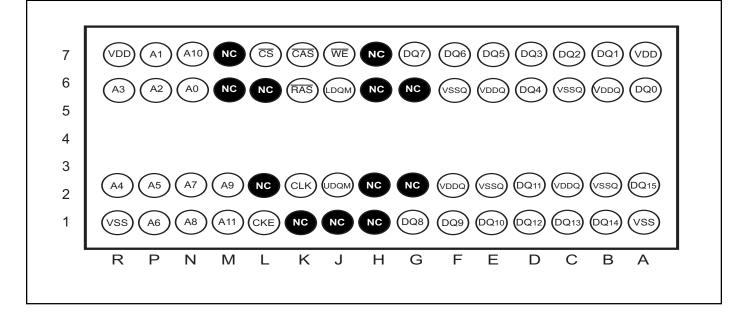
		•
vcc 🗖	1 50	GND GND
DQ0 🔳	2 49	DQ15
DQ1 🔳	3 48	DQ14
GNDQ 🔳	4 47	GNDQ
DQ2 🔲	5 46	DQ13
DQ3 🔳	6 45	DQ12
VCCQ 🔲	7 44	
DQ4 🔳	8 43	DQ11
DQ5	9 42	DQ10
GNDQ 🔳	10 41	🔟 GNDQ
DQ6	11 40	DQ9
DQ7	12 39	DQ8
VCCQ 🔲	13 38	
LDQM	14 37	
WE [15 36	UDQM
CAS 📗	16 35	D CLK
RAS 🔲	17 34	🔲 СКЕ
cs 🗖	18 33	
A11	19 32	A9
A10 [20 31	A8
A0 🔲	21 30	🔲 A7
A1 🔲	22 29	A6
A2 🔲	23 28	A 5
A3 🗌	24 27	A4
vcc 🗖	25 26	GND GND
		-

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IC42S16101



60-BALL VF-BGA (16M SDRAM)

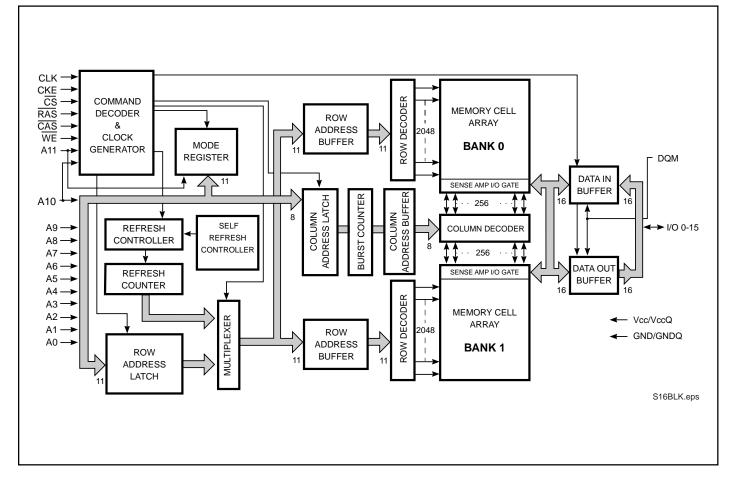


PIN DESCRIPTIONS

A0 - A10	Address	Row Address : RA0 - RA11, Column Address : CA0 - CA7 Auto-precharge flag : A10
A11	Bank Address	Selects bank to be activated during RAS activity Selects bank to be read/written during CAS activity
DQ0 - DQ15	Data Input/Output	Multiplexed data input / output pin
CLK	Clock	The system clock input.All other inputs are registered to the SDRAM on the rising edge of CLK
CKE	Clock Enable	Controls internal clock signal and when deactivated, the SDRAM will be one of the states among power down, suspend or self refresh
<u>CS</u>	Chip Select	Enables or disables all inputs except CLK, CKE and DQM
RAS	Row Address Strobe	RAS, CAS and WE define the operation
CAS	Column Address Strobe	Refer function truth table for details
WE	Write Enable	
LDQM,UDQM	Data Input/Output Mask	Controls output buffers in read mode and masks input data in write mode
VDD/VSS	Power Supply/Ground	Power supply for internal circuits and input buffers
VDDQ/VssQ	Data Output Power/Ground	Power supply for output buffers
NC	No Connection	No Connection



FUNCTIONAL BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Parameters	Rating	Unit
Vcc мах	Maximum Supply Voltage	-1.0 to +4.6	V
VCCQ MAX	Acco MAX Maximum Supply Voltage for Output Buffer		V
Vin	Input Voltage	-1.0 to +4.6	V
Vout	Output Voltage	-1.0 to +4.6	V
Pd max	Allowable Power Dissipation	1	W
lcs	Output Shorted Current	50	mA
Topr	Operating Temperature	0 to +70	°C
Tstg	Storage Temperature	–55 to +150	°C

DC RECOMMENDED OPERATING CONDITIONS⁽²⁾ (At T_A = 0 to +70°C)

Symbol	Parameter	Min.	Тур.	Max.	Unit
Vcc, VccQ	Supply Voltage	3.0	3.3	3.6	V
VIH	Input High Voltage ⁽³⁾	2.0	—	VDD + 0.3	V
Vı∟	Input Low Voltage ⁽⁴⁾	-0.3	—	+0.8	V

CAPACITANCE CHARACTERISTICS^(1,2) (At T_A = 0 to +25°C, Vcc = VccQ = 3.3 ± 0.3V, f = 1 MHz)

Symbol	Parameter	Тур.	Max.	Unit
CIN1	Input Capacitance: A0-A11		4	pF
CIN2	Input Capacitance: (CLK, CKE, CS, RAS, CAS, WE, LDQM, UDQM)		4	pF
CI/O	Data Input/Output Capacitance: I/O0-I/O15		5	рF

Notes:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. All voltages are referenced to GND.

3. VIH (max) = VCCQ + 2.0V with a pulse width \leq 3 ns.

4. V_{IL} (min) = GND – 2.0V with a pulse < 3 ns and -1.5V with a pulse < 5ns.



DC ELECTRICAL CHARACTERISTICS (Recommended Operation Conditions unless otherwise noted.)

Symbol	Parameter	Test Condition		Speed	Min.	Max.	Unit
lı∟	Input Leakage Current	$0V \le V_{IN} \le V_{CC}$, with pi the tested pin at $0V$	ns other than		-5	5	μA
Iol	Output Leakage Current	Output is disabled $0V \le V_{OUT} \le V_{CC}$			-10	10	μA
Vон	Output High Voltage Level	louτ = -2 mA			2.4		V
Vol	Output Low Voltage Level	Ιουτ = +2 mA				0.4	V
Icc1	Operating Current ^(1,2)	One Bank Operation,	CAS latency = 3	-5	_	150	mA
		Burst Length=1		-6		145	mA
		tRC ≥ tRC (min.) Iouт = 0mA		-7	—	140	mA
lcc2	Precharge Standby Current (In Power-Down Mode)	$CKE \le VIL (MAX)$	tck = tck (min)	—		2	mA
lcc3	Active Standby Current	CKE ≥ Vін (мім)	tcк = tcк (міл)	_	—5	50	mA
	(In Non Power-Down Mode)			—	—6	45	mΑ
				_	—7	40	mA
Icc4	Operating Current	tск = tск (міл)		-5		150	mΑ
	(In Burst Mode) ⁽¹⁾	Ιουτ = 0mA		-6		140	mΑ
				-7	—	130	mA
Icc5	Auto-Refresh Current	trc = trc (min)		-5	_	100	mA
				-6		90	mA
				-7		80	mΑ
Icc6	Self-Refresh Current	$CKE \le 0.2V$		_	_	1	mA

Notes:

 These are the values at the minimum cycle time. Since the currents are transient, these values decrease as the cycle time increases. Also note that a bypass capacitor of at least 0.01 μF should be inserted between Vcc and GND for each memory chip to suppress power supply voltage noise (voltage drops) due to these transient currents.

2. Icc1 and Icc4 depend on the output load.



AC CHARACTERISTICS^(1,2,3)

			-{	5	-(6	-7	7	
Symbol	Parameter		Min.	Max.	Min.	Max.	Min.	Max	Units
tск3	Clock Cycle Time CAS Lat	ency = 3	5	_	6	_	7	_	ns
tск2	CAS Lat	ency = 2	7	—	8	_	8.6	—	ns
tac3	Access Time From CLK ⁽⁴⁾ CAS Lat		_	4.5	_	5.5	—	6	ns
tac2	CAS Lat	ency = 2	_	5	_	6	—	6	ns
tсні	CLK HIGH Level Width		2	_	2	—	2.5	—	ns
tc∟	CLK LOW Level Width		2	_	2	_	2.5	_	ns
tон	Output Data Hold Time		2	—	2	—	2	—	ns
tlz	Output LOW Impedance Time		0	—	0	—	0	—	ns
tHz3	Output HIGH Impedance Time ⁽⁵⁾ CAS Lat	ency = 3	—	4.5	_	5.5	—	6	ns
tHz2	CAS Lat	ency = 2	_	5	_	6	_	6	ns
tos	Input Data Setup Time		2	_	2	_	2	—	ns
tdн	Input Data Hold Time		1	—	1	—	1	—	ns
tas	Address Setup Time		2	—	2	—	2	—	ns
tан	Address Hold Time		1	—	1	—	1	—	ns
tcкs	CKE Setup Time		2	_	2	—	2	—	ns
tскн	CKE Hold Time		1	—	1	—	1	_	ns
tска	CKE to CLK Recovery Delay Time	1	CLK+3	_	1CLK+3	_	1CLK+3	_	ns
tcs	Command Setup Time (CS, RAS, CAS, WE, DQM)		2		2	_	2	_	ns
tсн	Command Hold Time (CS, RAS, CAS, WE, DQM)		1	_	1	_	1	_	ns
trc	Command Period (REF to REF / ACT to ACT)		50	_	60	_	70	_	ns
tras	Command Period (ACT to PRE)		30	100,000	36	100,000	42	100,000	ns
t RP	Command Period (PRE to ACT)		15	_	18	_	21	_	ns
trcd	Active Command To Read / Write Command Delay Time		15	_	18	_	21	_	ns
trrd	Command Period (ACT [0] to ACT[1])		10	_	12	_	14	_	ns
t DPL	Input Data To Precharge		2CLK	_	2CLK	_	2CLK	_	ns
	Command Delay time								
t DAL	Input Data To Active / Refresh	20	CLK+tri	P —	2CLK+tra	> <u> </u>	2CLK+tra	» —	ns
	Command Delay time (During Auto-Precharge)								
t⊤Transiti	ion Time		1	10	1	10	1	10	ns
t REF	Refresh Cycle Time (4096)		_	64	_	64	_	64	ms

Notes:

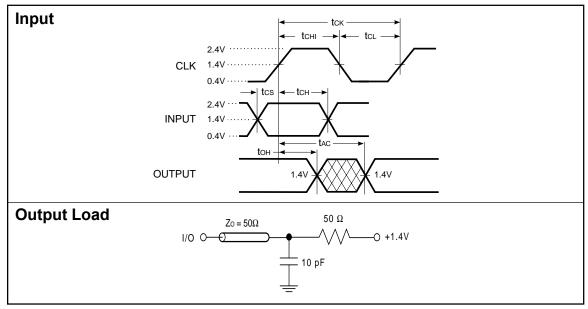
- 1. When power is first applied, memory operation should be started 100 µs after Vcc and VccQ reach their stipulated voltages. Also note that the power-on sequence must be executed before starting memory operation.
- 2. Measured with $t_T = 1$ ns.
- 3. The reference level is 1.4 V when measuring input signal timing. Rise and fall times are measured between V_{IH} (min.) and V_{IL} (max.).
- 4. Access time is measured at 1.4V with the load shown in the figure below.
- 5. The time tHZ (max.) is defined as the time required for the output voltage to transition by ± 200 mV from VOH (min.) or VOL (max.) when the output is in the high impedance state.



OPERATING FREQUENCY / LATENCY RELATIONSHIPS

Symbo	ol Parameter	-5	-6	-7	Units
_	Clock Cycle Time	5	6	7	ns
_	Operating Frequency	200	166	143	MHz
tcac	CAS Latency	3	3	3	cycle
t RCD	Active Command To Read/Write Command Delay Time	3	3	3	cycle
t RAC	RAS Latency (tRcD + tCAC)	6	6	6	cycle
trc	Command Period (REF to REF / ACT to ACT)	10	10	10	cycle
tras	Command Period (ACT to PRE)	6	6	6	cycle
t RP	Command Period (PRE to ACT)	3	3	3	cycle
t RRD	Command Period (ACT[0] to ACT [1])	2	2	2	cycle
tccd	Column Command Delay Time (READ, READA, WRIT, WRITA)	1	1	1	cycle
t dpl	Input Data To Precharge Command Delay Time	2	2	2	cycle
t DAL	Input Data To Active/Refresh Command Delay Time (During Auto-Precharge)	5	5	5	cycle
t rbd	Burst Stop Command To Output in HIGH-Z Delay Time (Read)	3	3	3	cycle
twвD	Burst Stop Command To Input in Invalid Delay Time (Write)	0	0	0	cycle
t RQL	Precharge Command To Output in HIGH-Z Delay Time (Read)	3	3	3	cycle
twdl	Precharge Command To Input in Invalid Delay Time (Write)	0	0	0	cycle
t PQL	Last Output To Auto-Precharge Start Time (Read)	-2	-2	-2	cycle
tqмd	DQM To Output Delay Time (Read)	2	2	2	cycle
t DMD	DQM To Input Delay Time (Write)	0	0	0	cycle
tмcd	Mode Register Set To Command Delay Time	2	2	2	cycle

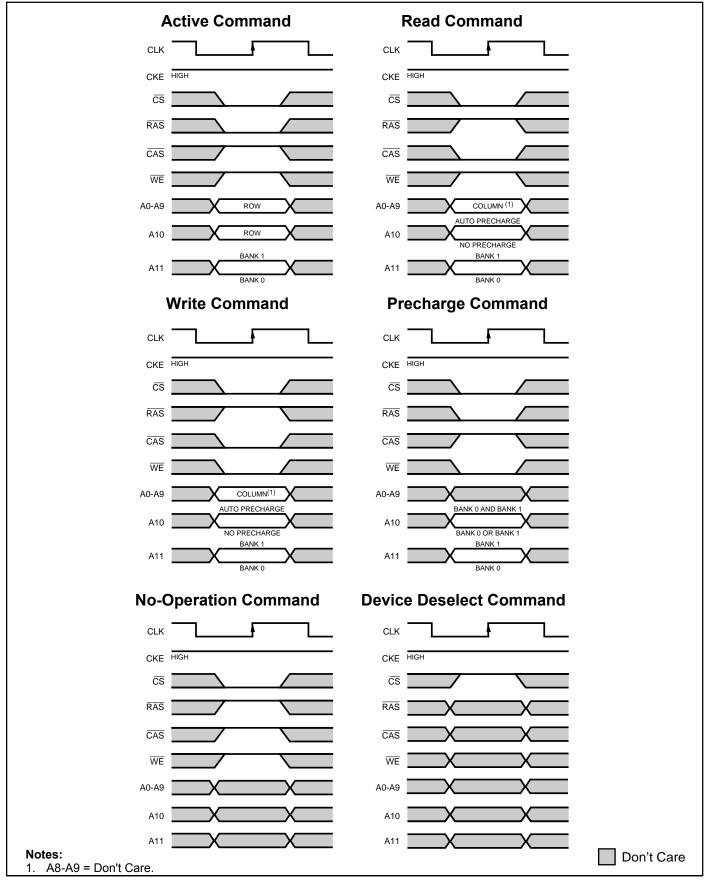
AC TEST CONDITIONS (Input/Output Reference Level: 1.4V)



IC42S16101



COMMANDS

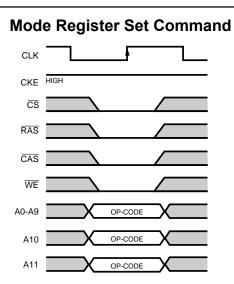


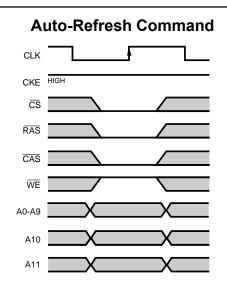
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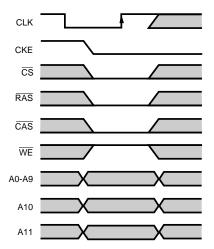


COMMANDS (cont.)

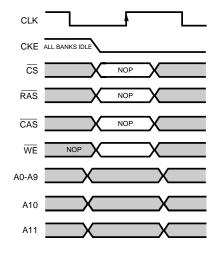




Self-Refresh Command



Power Down Command



Clock Suspend Command Burst Stop Command CLK CLK CKE BANK(S) ACTIVE CKE HIGH CS NOP CS NOP RAS RAS CAS NOP CAS WE NOP WE A0-A9 A0-A9

A10

A11

Don't Care



A10

A11



Mode Register Set Command

 $(\overline{CS}, \overline{RAS}, \overline{CAS}, \overline{WE} = LOW)$

The IC42S16101 product incorporates a register that defines the device operating mode. This command functions as a data input pin that loads this register from the pins A0 to A11. When power is first applied, the stipulated power-on sequence should be executed and then the IC42S16101 should be initialized by executing a mode register set command.

Note that the mode register set command can be executed only when both banks are in the idle state (i.e. deactivated).

Another command cannot be executed after a mode register set command until after the passage of the period t_{MCD}, which is the period required for mode register set command execution.

Active Command

 $(\overline{CS}, \overline{RAS} = LOW, \overline{CAS}, \overline{WE} = HIGH)$

The IC42S16101 includes two banks of 4096 rows each. This command selects one of the two banks according to the A11 pin and activates the row selected by the pins A0 to A10.

This command corresponds to the fall of the $\overline{\text{RAS}}$ signal from HIGH to LOW in conventional DRAMs.

Precharge Command

 $(\overline{CS}, \overline{RAS}, \overline{WE} = LOW, \overline{CAS} = HIGH)$

This command starts precharging the bank selected by pins A10 and A11. When A10 is HIGH, both banks are precharged at the same time. When A10 is LOW, the bank selected by A11 is precharged. After executing this command, the next command for the selected bank(s) is executed after passage of the period t_{RP} , which is the period required for bank precharging.

This command corresponds to the RAS signal from LOW to HIGH in conventional DRAMs

Read Command

 $(\overline{CS}, \overline{CAS} = LOW, \overline{RAS}, \overline{WE} = HIGH)$

This command selects the bank specified by the A11 pin and starts a burst read operation at the start address specified by pins A0 to A9. Data is output following CAS latency.

The selected bank must be activated before executing this command.

When the A10 pin is HIGH, this command functions as a read with auto-precharge command. After the burst read completes, the bank selected by pin A11 is precharged. When the A10 pin is LOW, the bank selected by the A11 pin remains in the activated state after the burst read completes.

Write Command

 $(\overline{CS}, \overline{CAS}, \overline{WE} = LOW, \overline{RAS} = HIGH)$

When burst write mode has been selected with the mode register set command, this command selects the bank specified by the A11 pin and starts a burst write operation at the start address specified by pins A0 to A9. This first data must be input to the I/O pins in the cycle in which this command.

The selected bank must be activated before executing this command.

When A10 pin is HIGH, this command functions as a write with auto-precharge command. After the burst write completes, the bank selected by pin A11 is precharged. When the A10 pin is low, the bank selected by the A11 pin remains in the activated state after the burst write completes.

After the input of the last burst write data, the application must wait for the write recovery period (tdpl, tdal) to elapse according to \overline{CAS} latency.

Auto-Refresh Command

 $(\overline{CS}, \overline{RAS}, \overline{CAS} = LOW, \overline{WE}, CKE = HIGH)$

This command executes the auto-refresh operation. The row address and bank to be refreshed are automatically generated during this operation.

Both banks must be placed in the idle state before executing this command.

The stipulated period (t_{RC}) is required for a single refresh operation, and no other commands can be executed during this period.

The device goes to the idle state after the internal refresh operation completes.

This command must be executed at least 4096 times every 64 ms.

This command corresponds to CBR auto-refresh in conventional DRAMs.

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Self-Refresh Command

 $(\overline{CS}, \overline{RAS}, \overline{CAS}, CKE = LOW, \overline{WE} = HIGH)$

This command executes the self-refresh operation. The row address to be refreshed, the bank, and the refresh interval are generated automatically internally during this operation. The self-refresh operation is started by dropping the CKE pin from HIGH to LOW. The self-refresh operation continues as long as the CKE pin remains LOW and there is no need for external control of any other pins. The self-refresh operation is terminated by raising the CKE pin from LOW to HIGH. The next command cannot be executed until the device internal recovery period (tRC) has elapsed. After the self-refresh, since it is impossible to determine the address of the last row to be refreshed, an auto-refresh should immediately be performed for all addresses (4096 cycles).

Both banks must be placed in the idle state before executing this command.

Burst Stop Command

 $(\overline{CS}, \overline{WE}, = LOW, \overline{RAS}, \overline{CAS} = HIGH)$

The command forcibly terminates burst read and write operations. When this command is executed during a burst read operation, data output stops after the \overline{CAS} latency period has elapsed.

No Operation

 $(\overline{CS}, = LOW, \overline{RAS}, \overline{CAS}, \overline{WE} = HIGH)$

This command has no effect on the device.

Device Deselect Command

 $(\overline{CS} = HIGH)$

This command does not select the device for an object of operation. In other words, it performs no operation with respect to the device.

Power-Down Command

(CKE = LOW)

When both banks are in the idle (inactive) state, or when at least one of the banks is not in the idle (inactive) state, this command can be used to suppress device power dissipation by reducing device internal operations to the absolute minimum. Power-down mode is started by dropping the CKE pin from HIGH to LOW. Power-down mode continues as long as the CKE pin is held low. All pins other than the CKE pin are invalid and none of the other commands can be executed in this mode. The powerdown operation is terminated by raising the CKE pin from LOW to HIGH. The next command cannot be executed until the recovery period (tckA) has elapsed.

Since this command differs from the self-refresh command described above in that the refresh operation is not performed automatically internally, the refresh operation must be performed within the refresh period (tREF). Thus the maximum time that power-down mode can be held is just under the refresh cycle time.

Clock Suspend

(CKE = LOW)

This command can be used to stop the device internal clock temporarily during a read or write cycle. Clock suspend mode is started by dropping the CKE pin from HIGH to LOW. Clock suspend mode continues as long as the CKE pin is held LOW. All input pins other than the CKE pin are invalid and none of the other commands can be executed in this mode. Also note that the device internal state is maintained. Clock suspend mode is terminated by raising the CKE pin from LOW to HIGH, at which point device operation restarts. The next command cannot be executed until the recovery period (tckA) has elapsed.

Since this command differs from the self-refresh command described above in that the refresh operation is not performed automatically internally, the refresh operation must be performed within the refresh period (tREF). Thus the maximum time that clock suspend mode can be held is just under the refresh cycle time.



COMMAND TRUTH TABLE^(1,2)

		СК	E									
Symbol	Command	n-1	n	<u>CS</u>	RAS	CAS	WE	DQM	A11	A10	A9-A0	l/On
MRS	Mode Register Set ^(3,4)	Н	Х	L	L	L	L	Х		OP CO	DE	Х
REF	Auto-Refresh ⁽⁵⁾	Н	Н	L	L	L	Н	Х	Х	Х	Х	HIGH-Z
SREF	Self-Refresh ^(5,6)	Н	L	L	L	L	Н	Х	Х	Х	Х	HIGH-Z
PRE	Precharge Selected Bank	Н	Х	L	L	Н	L	Х	BS	L	Х	Х
PALL	Precharge Both Banks	Н	Х	L	L	Н	L	Х	Х	Н	Х	Х
ACT	Bank Activate ⁽⁷⁾	Н	Х	L	L	Н	Н	Х	BS	Row	Row	Х
WRIT	Write	Н	Х	L	Н	L	L	Х	BS	L	Column ⁽¹⁸⁾	Х
WRITA	Write With Auto-Precharge ⁽⁸⁾	Н	Х	L	Н	L	L	Х	BS	Н	Column ⁽¹⁸⁾	Х
READ	Read ⁽⁸⁾	Н	Х	L	Н	L	Н	Х	BS	L	Column ⁽¹⁸⁾	Х
READA	Read With Auto-Precharge ⁽⁸⁾	Н	Х	L	Н	L	Н	Х	BS	Н	Column ⁽¹⁸⁾	Х
BST	Burst Stop ⁽⁹⁾	Н	Х	L	Н	Н	L	Х	Х	Х	Х	Х
NOP	No Operation	Н	Х	L	Н	Н	Н	Х	Х	Х	Х	Х
DESL	Device Deselect	Н	Х	Н	Х	Х	Х	Х	Х	Х	Х	Х
SBY	Clock Suspend / Standby Mode	L	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
ENB	Data Write / Output Enable	Н	Х	Х	Х	Х	Х	L	Х	Х	Х	Active
MASK	Data Mask / Output Disable	Н	Х	Х	Х	Х	Х	Н	Х	Х	Х	HIGH-Z

DQM TRUTH TABLE^(1,2)

		СК	E	DQM		
Symbol	Command	n-1	n	UPPER	LOWER	
ENB	Data Write / Output Enable	Н	Х	L	L	
MASK	Data Mask / Output Disable	Н	Х	Н	Н	
ENBU	Upper Byte Data Write / Output Enable	Н	Х	L	Х	
ENBL	Lower Byte Data Write / Output Enable	Н	Х	Х	L	
MASKU	Upper Byte Data Mask / Output Disable	Н	Х	Н	Х	
MASKL	Lower Byte Data Mask / Output Disable	Н	Х	Х	Н	

CKE TRUTH TABLE^(1,2)

			CK	Έ							
Symbol	Command	Current State	n-1	n	CS	RAS	CAS	WE	A11	A10	A9-A0
SPND	Start Clock Suspend Mode	Active	Н	L	Х	Х	Х	Х	Х	Х	Х
—	Clock Suspend	Other States	L	L	Х	Х	Х	Х	Х	Х	Х
_	Terminate Clock Suspend Mode	Clock Suspend	L	Н	Х	Х	Х	Х	Х	Х	Х
REF	Auto-Refresh	Idle	Н	Н	L	L	L	Н	Х	Х	Х
SELF	Start Self-Refresh Mode	ldle	Н	L	L	L	L	Н	Х	Х	Х
SELFX	Terminate Self-Refresh Mode	Self-Refresh	L	Н	L	Н	Н	Н	Х	Х	Х
			L	Н	Н	Х	Х	Х	Х	Х	Х
PDWN	Start Power-Down Mode	Idle	Н	L	L	Н	Н	Н	Х	Х	Х
			Н	L	Н	Х	Х	Х	Х	Х	Х
_	Terminate Power-Down Mode	Power-Down	L	Н	Х	Х	Х	Х	Х	Х	Х

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OPERATION COMMAND TABLE^(1,2)



Current State	Command	Operation	<u>CS</u>	RAS	CAS	WE	A11	A10	A9-A
Idle	DESL	No Operation or Power-Down ⁽¹²⁾	Н	Х	Х	Х	Х	Х	Х
	NOP	No Operation or Power-Down ⁽¹²⁾	L	Н	Н	Н	Х	Х	Х
	BST	No Operation or Power-Down	L	Н	Н	L	Х	Х	Х
	READ / READA	Illegal	L	Н	L	Н	V	V	V(18
	WRIT/WRITA	Illegal	L	Н	L	L	V	V	V(18
	ACT	Row Active	L	L	Н	Н	V	V	V(18
	PRE/PALL	No Operation	L	L	Н	L	V	V	Х
	REF/SELF	Auto-Refresh or Self-Refresh ⁽¹³⁾	L	L	L	Н	Х	Х	Х
	MRS	Mode Register Set	L	L	L	L	0	P COI	DE
Row Active	DESL	No Operation	Н	Х	Х	Х	Х	Х	Х
	NOP	No Operation	L	Н	Н	Н	Х	Х	Х
	BST	No Operation	L	Н	Н	L	Х	Х	Х
	READ/READA	Read Start ⁽¹⁷⁾	L	Н	L	Н	V	V	V(18
	WRIT/WRITA	Write Start ⁽¹⁷⁾	L	Н	L	L	V	V	V(18
	ACT	Illegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V(18
	PRE/PALL	Precharge ⁽¹⁵⁾	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	Н	Х	Х	Х
	MRS	llegal	L	L	L	L		P COI	
Read	DESL	Burst Read Continues, Row Active When Done	Н	Х	Х	Х	Х	Х	Х
	NOP	Burst Read Continues, Row Active When Done	L	Н	Н	Н	Х	Х	Х
	BST	Burst Interrupted, Row Active After Interrupt	L	Н	Н	L	Х	Х	Х
	READ/READA	Burst Interrupted, Read Restart After Interrupt ⁽¹⁶⁾	L	Н	L	Н	V	V	V(18
	WRIT/WRITA	Burst Interrupted Write Start After Interrupt ^(11,16)	L	Н	L	L	V	V	V(18
	ACT	Illegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V(18
	PRE/PALL	Burst Read Interrupted, Precharge After Interrupt	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	H	X	X	Х
	MRS	llegal	L	L	L	L		P COI	
Write	DESL	Burst Write Continues, Write Recovery When Done	 H	X	X	X	X	X	X
	NOP	Burst Write Continues, Write Recovery When Done	L	H	H	Ĥ	X	Х	X
	BST	Burst Write Interrupted, Row Active After Interrupt	L	Н	H	L	X	X	X
	READ/READA	Burst Write Interrupted, Read Start After Interrupt ^(11,16)	-	н	1	H	V	V	V(18
	WRIT/WRITA	Burst Write Interrupted, Write Restart After Interrupt ⁽¹⁶⁾	-	Н	-	1	v	v	V(18
	ACT	Illegal ⁽¹⁰⁾	-	L	H	H	v	v	V(18
	PRE/PALL	Burst Write Interrupted, Precharge After Interrupt	-	L	н	L	v	v	X
	REF/SELF	Illegal	-	L	L	H	x	x	X
	MRS	llegal	L	L	L	L			
Read With	DESL	Burst Read Continues, Precharge When Done	H	X	X	X	X	X	X
Auto-	NOP	Burst Read Continues, Precharge When Done	L	Ĥ	Ĥ	Ĥ	X	X	X
Precharge	BST	lllegal	L	Н	Н	L	X	Х	X
J- J-	READ/READA	llegal	L	Н	L	- H	V	V	V(18
	WRIT/WRITA	llegal	Ē	Н	L	L	v	v	V(18
	ACT	Illegal ⁽¹⁰⁾	Ē	L	H	Н	v	v	V(18
	PRE/PALL	Illegal ⁽¹⁰⁾	-	L	н	L	v	V	X
	REF/SELF	llegal	1	L	L	Н	v X	X	X
			L .		L	11	~ ~	~	~ ^



OPERATION COMMAND TABLE^(1,2)

Current State	Command	Operation	<u>CS</u>	RAS	CAS	WE	A11	A10	A9-A0
Write With Auto-Precharge	DESL	Burst Write Continues, Write Recovery And Precharge When Done	Η	Х	Х	Х	Х	Х	Х
	NOP	Burst Write Continues, Write Recovery And Precharge	L	Н	Н	Н	Х	Х	Х
	BST	lllegal	L	Н	Н	L	Х	Х	Х
	READ/READA	Illegal	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	lllegal	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	Illegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	Illegal ⁽¹⁰⁾	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	Н	Х	Х	Х
	MRS	Illegal	L	L	L	L	C	PCOE	ЭE
Row Precharge	DESL	No Operation, Idle State After tRP Has Elapsed	Н	Х	Х	Х	Х	Х	Х
_	NOP	No Operation, Idle State After tRP Has Elapsed	L	Н	Н	Н	Х	Х	Х
	BST	No Operation, Idle State After tRP Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	Illegal ⁽¹⁰⁾	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	Illegal ⁽¹⁰⁾	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	Illegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	No Operation, Idle State After tRP Has Elapsed ⁽¹⁰⁾	L	L	Н	L	V	V	Х
	REF/SELF	llegal	L	L	L	Н	Х	Х	Х
	MRS	llegal	L	L	L	L	С	P COI	DE
Immediately	DESL	No Operation, Row Active After tRCD Has Elapsed	Н	Х	Х	Х	Х	Х	Х
Following	NOP	No Operation, Row Active After tRcD Has Elapsed	L	Н	Н	Н	Х	Х	Х
Row Active	BST	No Operation, Row Active After tRCD Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	Illegal ⁽¹⁰⁾	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	Illegal ⁽¹⁰⁾	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	Illegal ^(10,14)	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	Illegal ⁽¹⁰⁾	L	L	Н	L	V	V	Х
	REF/SELF	Illegal	L	L	L	Н	Х	Х	Х
	MRS	Illegal	L	L	L	L	С	P CO	DE
Write	DESL	No Operation, Row Active After tDPL Has Elapsed	Н	Х	Х	Х	Х	Х	Х
Recovery	NOP	No Operation, Row Active After tDPL Has Elapsed	L	Н	Н	Н	Х	Х	Х
	BST	No Operation, Row Active After tDPL Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	Read Start	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	Write Restart	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	Illegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	Illegal ⁽¹⁰⁾	L	L	Н	L	V	V	Х
	REF/SELF	Illegal	L	L	L	Н	Х	Х	Х
	MRS	Illegal	L	L	L	L	С	P COI	DE

OPERATION COMMAND TABLE^(1,2)



Current State	Command	Operation	<u>CS</u>	RAS	CAS	WE	A11	A10	A9-A0
Write Recovery	DESL	No Operation, Idle State After tDAL Has Elapsed	Н	Х	Х	Х	Х	Х	Х
With Auto-	NOP	No Operation, Idle State After tDAL Has Elapsed	L	Н	Н	Н	Х	Х	Х
Precharge	BST	No Operation, Idle State After tDAL Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	lllegal ⁽¹⁰⁾	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	llegal ⁽¹⁰⁾	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	llegal ⁽¹⁰⁾	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	Illegal ⁽¹⁰⁾	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	Н	Х	Х	Х
	MRS	lllegal	L	L	L	L	С	P COI	DE
Refresh	DESL	No Operation, Idle State After tRP Has Elapsed	Н	Х	Х	Х	Х	Х	Х
	NOP	No Operation, Idle State After tre Has Elapsed	L	Н	Н	Н	Х	Х	Х
	BST	No Operation, Idle State After tre Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	lllegal	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	lllegal	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	lllegal	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	lllegal	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	Н	Х	Х	Х
	MRS	Illegal	L	L	L	L	С	P COI	DE
Mode Register	DESL	No Operation, Idle State After tMcD Has Elapsed	Н	Х	Х	Х	Х	Х	Х
Set	NOP	No Operation, Idle State After tMCD Has Elapsed	L	Н	Н	Н	Х	Х	Х
	BST	No Operation, Idle State After tMCD Has Elapsed	L	Н	Н	L	Х	Х	Х
	READ/READA	lllegal	L	Н	L	Н	V	V	V ⁽¹⁸⁾
	WRIT/WRITA	llegal	L	Н	L	L	V	V	V ⁽¹⁸⁾
	ACT	llegal	L	L	Н	Н	V	V	V ⁽¹⁸⁾
	PRE/PALL	lllegal	L	L	Н	L	V	V	Х
	REF/SELF	lllegal	L	L	L	Н	Х	Х	Х
	MRS	Illegal	L	L	L	L	C	P COI	DE

Notes:

- 1. H: HIGH level input, L: LOW level input, X: HIGH or LOW level input, V: Valid data input
- 2. All input signals are latched on the rising edge of the CLK signal.
- 3. Both banks must be placed in the inactive (idle) state in advance.
- 4. The state of the A0 to A11 pins is loaded into the mode register as an OP code.
- 5. The row address is generated automatically internally at this time. The I/O pin and the address pin data is ignored.
- 6. During a self-refresh operation, all pin data (states) other than CKE is ignored.
- 7. The selected bank must be placed in the inactive (idle) state in advance.
- 8. The selected bank must be placed in the active state in advance.
- 9. This command is valid only when the burst length set to full page.
- 10. This is possible depending on the state of the bank selected by the A11 pin.
- 11. Time to switch internal busses is required.
- 12. The IS42S16101can be switched to power-down mode by dropping the CKE pin LOW when both banks in the idle state. Input pins other than CKE are ignored at this time.
- 13. The IS42S16101 can be switched to self-refresh mode by dropping the CKE pin LOW when both banks in the idle state. Input pins other than CKE are ignored at this time.
- 14. Possible if tRRD is satisfied.
- 15. Illegal if tRAS is not satisfied.
- 16. The conditions for burst interruption must be observed. Also note that the IS42S16101 will enter the precharged state immediately after the burst operation completes if auto-precharge is selected.
- 17. Command input becomes possible after the period tRCD has elapsed. Also note that the IS42S16101 will enter the precharged state immediately after the burst operation completes if auto-precharge is selected.
- 18. A8,A9 = don't care.

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CKE RELATED COMMAND TRUTH TABLE⁽¹⁾

		Ck	(E							
Current State	Operation	n-1	n	CS	RAS	CAS	WE	A11	A10	A9-A0
Self-Refresh	Undefined	Н	Х	Х	Х	Х	Х	Х	Х	Х
	Self-Refresh Recovery ⁽²⁾	L	Н	Н	Х	Х	Х	Х	Х	Х
	Self-Refresh Recovery ⁽²⁾	L	Н	L	Н	Н	Х	Х	Х	Х
	Illegal ⁽²⁾	L	Н	L	Н	L	Х	Х	Х	Х
	Illegal ⁽²⁾	L	Н	L	L	Х	Х	Х	Х	Х
	Self-Refresh	L	L	Х	Х	Х	Х	Х	Х	Х
Self-Refresh Recovery	Idle State After tRc Has Elapsed	Н	Н	Н	Х	Х	Х	Х	Х	Х
	Idle State After tRC Has Elapsed	Н	Н	L	Н	Н	Х	Х	Х	Х
	lllegal	Н	Н	L	Н	L	Х	Х	Х	Х
	llegal	Н	Н	L	L	Х	Х	Х	Х	Х
	Power-Down on the Next Cycle	Н	L	Н	Х	Х	Х	Х	Х	Х
	Power-Down on the Next Cycle	Н	L	L	Н	Н	Х	Х	Х	Х
	lllegal	Н	L	L	Н	L	Х	Х	Х	Х
	llegal	Н	L	L	L	Х	Х	Х	Х	Х
	Clock Suspend Termination on the Next Cycle (2)	L	Н	Х	Х	Х	Х	Х	Х	Х
	Clock Suspend	L	L	Х	Х	Х	Х	Х	Х	Х
Power-Down	Undefined	Н	Х	Х	Х	Х	Х	Х	Х	Х
	Power-Down Mode Termination, Idle After That Termination ⁽²⁾	L	Η	Х	Х	Х	Х	Х	Х	Х
	Power-Down Mode	L	L	Х	Х	Х	Х	Х	Х	Х
Both Banks Idle	No Operation	Н	Н	Н	Х	Х	Х	Х	Х	Х
	See the Operation Command Table	Н	Н	L	Н	Х	Х	Х	Х	Х
	Bank Active Or Precharge	Н	Н	L	L	Н	Х	Х	Х	Х
	Auto-Refresh	Н	Н	L	L	L	Н	Х	Х	Х
	Mode Register Set	Н	Н	L	L	L	L	С	P COI	DE
	See the Operation Command Table	Н	L	Н	Х	Х	Х	Х	Х	Х
	See the Operation Command Table	Н	L	L	Н	Х	Х	Х	Х	Х
	See the Operation Command Table	Н	L	L	L	Н	Х	Х	Х	Х
	Self-Refresh ⁽³⁾	Н	L	L	L	L	Н	Х	Х	Х
	See the Operation Command Table	Н	L	L	L	L	L	С	P COI	DE
	Power-Down Mode ⁽³⁾	L	Х	Х	Х	Х	Х	Х	Х	Х
Other States	See the Operation Command Table	Н	Н	Х	Х	Х	Х	Х	Х	Х
	Clock Suspend on the Next Cycle ⁽⁴⁾	Н	L	Х	Х	Х	Х	Х	Х	Х
	Clock Suspend Termination on the Next Cycle	L	Н	Х	Х	Х	Х	Х	Х	Х
	Clock Suspend Termination on the Next Cycle	L	L	Х	Х	Х	Х	Х	Х	Х

Notes:

 H: HIGH level input, L: LOW level input, X: HIGH or LOW level input
The CLK pin and the other input are reactivated asynchronously by the transition of the CKE level from LOW to HIGH. The minimum setup time (tCKA) required before all commands other than mode termination must be satisfied.

3. Both banks must be set to the inactive (idle) state in advance to switch to power-down mode or self-refresh mode.

4. The input must be command defined in the operation command table.

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TWO BANKS OPERATION COMMAND TRUTH TABLE^(1,2)

Operation	<u>cs</u>	RAS	CAS	WE	A11	A10	A9-A0	Previou BANK 0	is State BANK 1	Next St BANK 0	
DESL	Н	Х	Х	Х	Х	Х	Х	Any	Any	Any	Any
NOP	L	Н	Н	Н	Х	Х	Х	Any	Any	Any	Any
BST	L	Н	Н	L	Х	Х	Х	R/W/A	I/A	А	I/A
								I	I/A	I	I/A
								I/A	R/W/A	I/A	А
								I/A		I/A	
READ/READA	L	Н	L	Н	Н	Н	CA ⁽³⁾	I/A	R/W/A	I/A	RP
					Н	Н	CA ⁽³⁾	R/W	А	А	RP
					Н	L	CA ⁽³⁾	I/A	R/W/A	I/A	R
					Н	L	CA ⁽³⁾	R/W	А	А	R
					L	Н	CA ⁽³⁾	R/W/A	I/A	RP	I/A
					L	Н	CA ⁽³⁾	А	R/W	RP	А
					L	L	CA ⁽³⁾	R/W/A	I/A	R	I/A
					L	L	CA ⁽³⁾	А	R/W	R	А
WRIT/WRITA	L	Н	L	L	Н	Н	CA ⁽³⁾	I/A	R/W/A	I/A	WP
					Н	Н	CA ⁽³⁾	R/W	А	А	WP
					Н	L	CA ⁽³⁾	I/A	R/W/A	I/A	W
					Н	L	CA ⁽³⁾	R/W	А	А	W
					L	Н	CA ⁽³⁾	R/W/A	I/A	WP	I/A
					L	Н	CA ⁽³⁾	А	R/W	WP	А
					L	L	CA ⁽³⁾	R/W/A	I/A	W	I/A
					L	L	CA ⁽³⁾	А	R/W	W	А
ACT	L	L	Н	Н	Н	RA	RA	Any	I	Any	А
					L	RA	RA	l	Any	A	Any
PRE/PALL	L	L	Н	L	Х	Н	Х	R/W/A/I	I/A		I
					Х	Н	Х	I/A	R/W/A/I	I	I
					Н	L	Х	I/A	R/W/A/I	I/A	I
					Н	L	Х	R/W/A/I	I/A	R/W/A/I	I
					L	L	Х	R/W/A/I	I/A		I/A
					L	L	Х	I/A	R/W/A/I		R/W/A/I
REF	L	L	L	Н	Х	Х	Х		I		I
MRS	L	L	L	L	C	PCOE	DE	I	I	I	I

Notes:

1. H: HIGH level input, L: LOW level input, X: HIGH or LOW level input, RA: Row Address, CA: Column Address

2. The device state symbols are interpreted as follows:

I Idle (inactive state)

A Row Active State

R Read

W Write

RP Read With Auto-Precharge

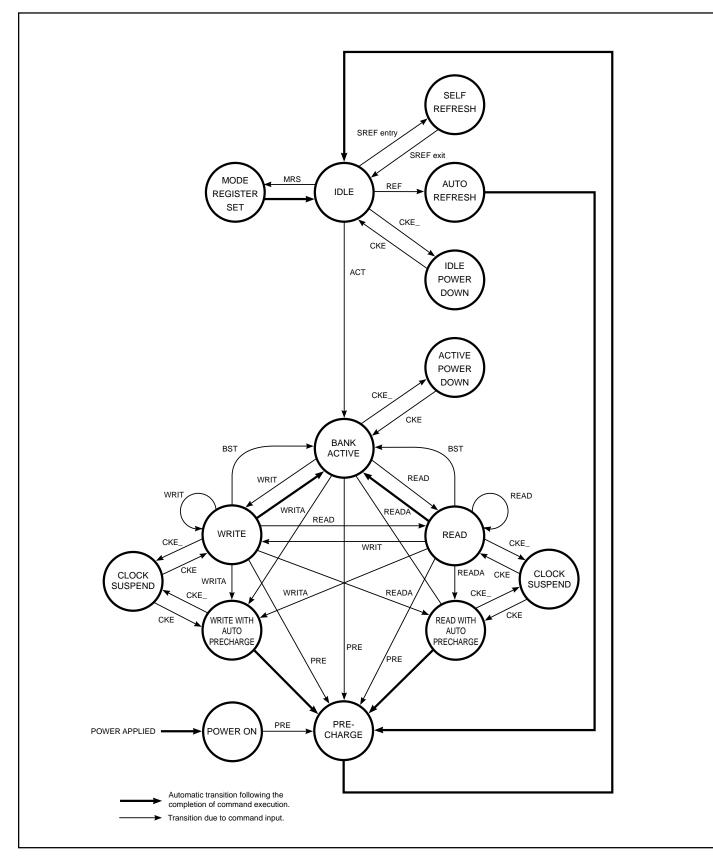
WP Write With Auto-Precharge

Any Any State

3. CA: A8,A9 = don't care.



SIMPLIFIED STATE TRANSITION DIAGRAM (One Bank Operation)



Integrated Circuit Solution Inc. DR025-0F 01/17/2005



Device Initialization At Power-On

(Power-On Sequence)

As is the case with conventional DRAMs, the IC42S16101 product must be initialized by executing a stipulated poweron sequence after power is applied.

After power is applied and Vcc and VccQ reach their stipulated voltages, set and hold the CKE and DQM pins HIGH for 100 μ s. Then, execute the precharge command to precharge both bank. Next, execute the auto-refresh command twice or more and define the device operation mode by executing a mode register set command.

The mode register set command can be also set before auto-refresh command.

Mode Register Settings

The mode register set command sets the mode register. When this command is executed, pins A0 to A9, A10, and A11 function as data input pins for setting the register, and this data becomes the device internal OP code. This OP code has four fields as listed in the table below.

Input Pin	Field	
A11, A10, A9, A8	Mode Options	
A6, A5, A4	CAS Latency	
A3	Burst Type	
A2, A1, A0	Burst Length	

Note that the mode register set command can be executed only when both banks are in the idle (inactive) state. Wait at least two cycles after executing a mode register set command before executing the next command.

CAS Latency

During a read operation, the between the execution of the read command and data output is stipulated as the \overline{CAS} latency. This period can be set using the mode register set command. The optimal \overline{CAS} latency is determined by the clock frequency and device speed grade (-10/12). See the "Operating Frequency / Latency Relationships" item for details on the relationship between the clock frequency and the \overline{CAS} latency. See the table on the next page for details on setting the mode register.

Burst Length

When writing or reading, data can be input or output data continuously. In these operations, an address is input only once and that address is taken as the starting address internally by the device. The device then automatically generates the following address. The burst length field in the mode register stipulates the number of data items input or output in sequence. In the IC42S16101 product, a burst length of 1, 2, 4, 8, or full page can be specified. See the table on the next page for details on setting the mode register.

Burst Type

The burst data order during a read or write operation is stipulated by the burst type, which can be set by the mode register set command. The IC42S16101 product supports sequential mode and interleaved mode burst type settings. See the table on the next page for details on setting the mode register. See the "Burst Length and Column Address Sequence" item for details on I/O data orders in these modes.

Write Mode

Burst write or single write mode is selected by the OP code (A11, A10, A9) of the mode register.

A burst write operation is enabled by setting the OP code (A11, A10, A9) to (0,0,0). A burst write starts on the same cycle as a write command set. The write start address is specified by the column address and bank select address at the write command set cycle.

A single write operation is enabled by setting OP code (A11, A10, A9) to (0,0,1). In a single write operation, data is only written to the column address and bank select address specified by the write command set cycle without regard to the bust length setting.



MODE REGISTER

1	10	9	8	7	6	5	4	3	2	1	0		Addre Mode			(My)	
	WRI	TE M	ODE		Ľ	T MOE)E	BT 		BL		-	Mode	Rey	ISLEI		
													M2	M1	MO	Sequential	Interleaved
												Burst Length	0	0	0	1	1
												Ŭ	0	0	1	2	2
													0	1	0	4	4
													0	1	1	8	8
													1	0	0	Reserved	Reserved
													1	0	1	Reserved	Reserved
													1	1	0	Reserved	Reserved
													1	1	1	Full Page	Reserved
													M3		Туре		
											E	Burst Type	0	S	Sequent	ial	
													1	Ir	nterleav	ed	
													M6	M5	M4	CAS Latency	
												atency Mode	0	0	0	Reserved	
											_	-, , ,	0	0	1	Reserved	
													0	1	0	2	
													0	1	1	3	
													1	0	0	Reserved	
													1	0	1	Reserved	
													1	1	0	Reserved	
													1	1	1	Reserved	

M11	M10	M9	M8	M7	Write Mode
0	0	0	0	0	Burst Read & Burst Write
0	0	1	0	0	Burst Read & Single Write
		others			Reserved



BURST LENGTH AND COLUMN ADDRESS SEQUENCE

	Colun	nn Ao	ddress	Address S	Sequence
Burst Length	A2	A1	A0	Sequential	Interleaved
2	Х	Х	0	0-1	0-1
	Х	Х	1	1-0	1-0
4	Х	0	0	0-1-2-3	0-1-2-3
	Х	0	1	1-2-3-0	1-0-3-2
	Х	1	0	2-3-0-1	2-3-0-1
	Х	1	1	3-0-1-2	3-2-1-0
8	0	0	0	0-1-2-3-4-5-6-7	0-1-2-3-4-5-6-7
	0	0	1	1-2-3-4-5-6-7-0	1-0-3-2-5-4-7-6
	0	1	0	2-3-4-5-6-7-0-1	2-3-0-1-6-7-4-5
	0	1	1	3-4-5-6-7-0-1-2	3-2-1-0-7-6-5-4
	1	0	0	4-5-6-7-0-1-2-3	4-5-6-7-0-1-2-3
	1	0	1	5-6-7-0-1-2-3-4	5-4-7-6-1-0-3-2
	1	1	0	6-7-0-1-2-3-4-5	6-7-4-5-2-3-0-1
	1	1	1	7-0-1-2-3-4-5-6	7-6-5-4-3-2-1-0
Full Page	n	n	n	Cn, Cn+1, Cn+2	None
(256)				Cn+3, Cn+4	
· · ·				Cn-1(Cn+255),	
				Cn(Cn+256)	

Notes:

1. The burst length in full page mode is 256.



BANK SELECT AND PRECHARGE ADDRESS ALLOCATION

٧٥		
	_	Row Address
		Row Address
	_	Row Address
X3		Row Address
		Row Address
X5	_	Row Address
X6	_	Row Address
X7	—	Row Address
X8	—	Row Address
X9	_	Row Address
X10	0	Precharge of the Selected Bank (Precharge Command) Row Address
	1	Precharge of Both Banks (Precharge Command) (Active Command)
X11	0	Bank 0 Selected (Precharge and Active Command)
	1	Bank 1 Selected (Precharge and Active Command)
Y0	_	Column Address
Y1		Column Address
Y2		Column Address
Y3	_	Column Address
Y4	_	Column Address
Y5	—	Column Address
Y6	—	Column Address
Y7	_	Column Address
Y8	_	Don't Care
Y9	_	Don't Care
Y10	0	Auto-Precharge - Disabled
	1	Auto-Precharge - Enables
Y11	0	Bank 0 Selected (Read and Write Commands)
	1	Bank 1 Selected (Read and Write Commands)
	X7 X8 X9 X10 X11 Y0 Y1 Y2 Y3 Y4 Y5 Y6 Y7 Y8 Y9 Y10	$\begin{array}{cccccccccccccccccccccccccccccccccccc$



Burst Read

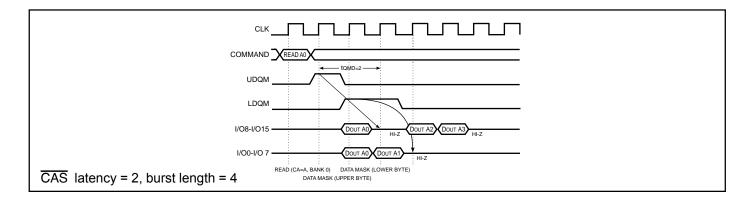
The read cycle is started by executing the read command. The address provided during read command execution is used as the starting address. First, the data corresponding to this address is output in synchronization with the clock signal after the CAS latency period. Next, data corresponding to an address generated automatically by the device is output in synchronization with the clock signal.

The output buffers go to the LOW impedance state CAS latency minus one cycle after the read command, and go to the HIGH impedance state automatically after the last data is output. However, the case where the burst length

is a full page is an exception. In this case the output buffers must be set to the high impedance state by executing a burst stop command.

Note that upper byte and lower byte output data can be masked independently under control of the signals applied to the U/LDQM pins. The delay period (t_{QMD}) is fixed at two, regardless of the CAS latency setting, when this function is used.

The selected bank must be set to the active state before executing this command.



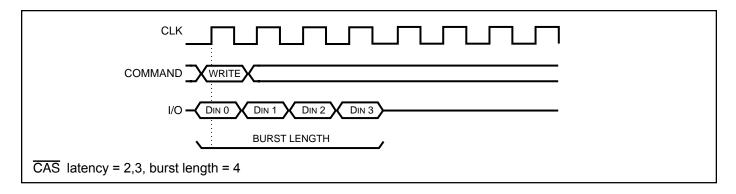
Burst Write

The write cycle is started by executing the command. The address provided during write command execution is used as the starting address, and at the same time, data for this address is input in synchronization with the clock signal.

Next, data is input in other in synchronization with the clock signal. During this operation, data is written to address generated automatically by the device. This cycle terminates automatically after a number of clock cycles determined by the stipulated burst length. However, the case where the burst length is a full page is an exception. In this case the write cycle must be terminated by executing a burst stop command. The latency for I/O pin data input is zero,

regardless of the \overline{CAS} latency setting. However, a wait period (write recovery: tDPL) after the last data input is required for the device to complete the write operation.

Note that the upper byte and lower byte input data can be masked independently under control of the signals applied to the U/LDQM pins. The delay period (t_{DMD}) is fixed at zero, regardless of the CAS latency setting, when this function is used.





Read With Auto-Precharge

The read with auto-precharge command first executes a burst read operation and then puts the selected bank in the precharged state automatically. After the precharge completes, the bank goes to the idle state. Thus this command performs a read command and a precharge command in a single operation.

During this operation, the delay period (t_{PQL}) between the last burst data output and the start of the precharge operation differs depending on the CAS latency setting.

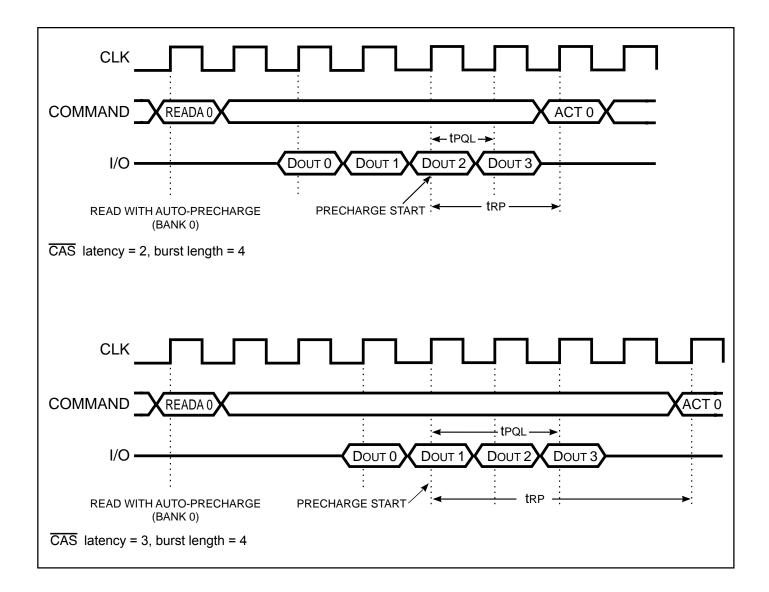
When the \overline{CAS} latency setting is two, the precharge operation starts on one clock cycle before the last burst data is output (tPQL = -1). When the \overline{CAS} latency setting is

three, the precharge operation starts on two clock cycles before the last burst data is output ($t_{PQL} = -2$). Therefore, the selected bank can be made active after a delay of t_{RP} from the start position of this precharge operation.

The selected bank must be set to the active state before executing this command.

The auto-precharge function is invalid if the burst length is set to full page.

CAS Latency	3	2	
t PQL	-2	-1	





Write With Auto-Precharge

The write with auto-precharge command first executes a burst write operation and then puts the selected bank in the precharged state automatically. After the precharge completes the bank goes to the idle state. Thus this command performs a write command and a precharge command in a single operation.

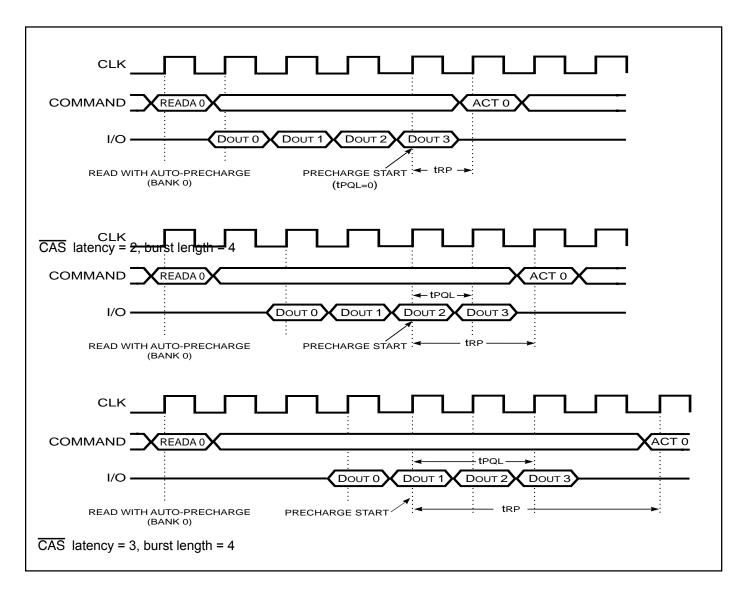
During this operation, the delay period (tDAL) between the last burst data input and the completion of the precharge operation differs depending on the \overline{CAS} latency setting. The delay (tDAL) is tRP plus one CLK period. That is, the precharge operation starts one clock period after the last burst data input.

Therefore, the selected bank can be made active after a delay of tDAL.

The selected bank must be set to the active state before executing this command.

The auto-precharge function is invalid if the burst length is set to full page.

CAS Latency	3	2	
t DAL	1CLK	1CLK	
	+t _{RP}	+t _{RP}	



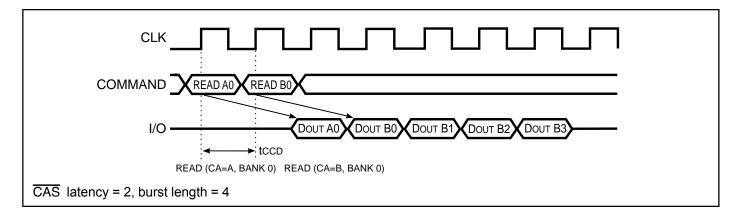


Interval Between Read Command

A new command can be executed while a read cycle is in progress, i.e., before that cycle completes. When the second read command is executed, after the \overline{CAS} latency has elapsed, data corresponding to the new read command is output in place of the data due to the previous read command.

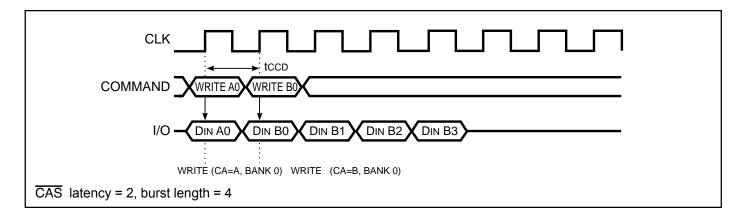
The interval between two read command (tccd) must be at least one clock cycle.

The selected bank must be set to the active state before executing this command.



Interval Between Write Command

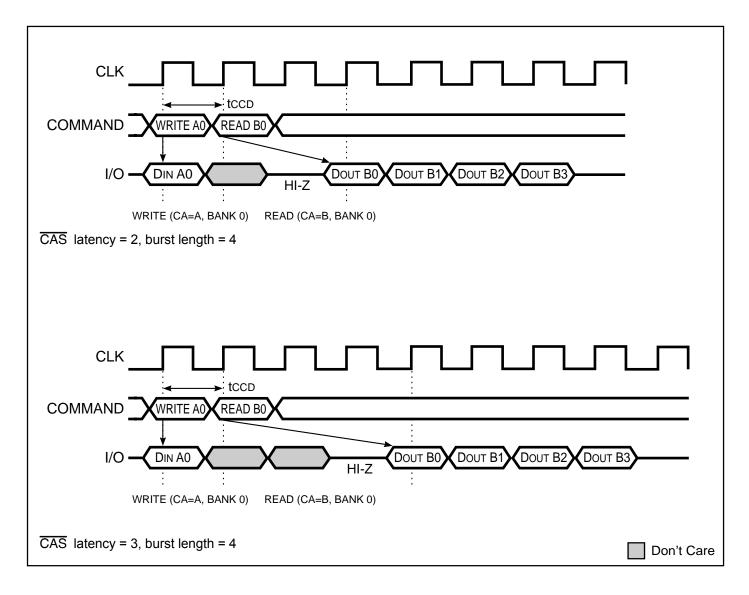
A new command can be executed while a write cycle is in progress, i.e., before that cycle completes. At the point the second write command is executed, data corresponding to the new write command can be input in place of the data for the previous write command. The interval between two write commands (tccd) must be at least one clock cycle.





Interval Between Write and Read Commands

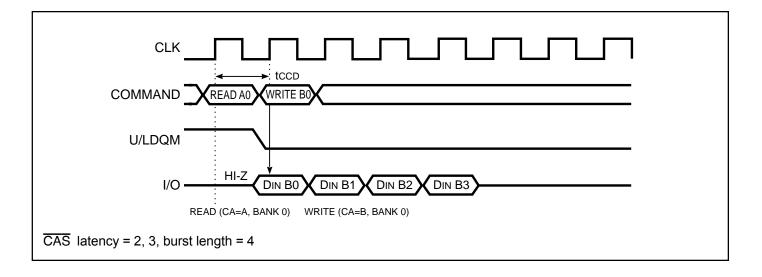
A new read command can be executed while a write cycle is in progress, i.e., before that cycle completes. Data corresponding to the new read command is output after the CAS latency has elapsed from the point the new read command was executed. The I/On pins must be placed in the HIGH impedance state at least one cycle before data is output during this operation. The interval (tccd) between command must be at least one clock cycle.





Interval Between Read and Write Commands

A read command can be interrupted and a new write command executed while the read cycle is in progress, i. e., before that cycle completes. Data corresponding to the new write command can be input at the point new write command is executed. To prevent collision between input and output data at the I/On pins during this operation, the output data must be masked using the U/LDQM pins. The interval (tccd) between these commands must be at least one clock cycle.





Precharge

The precharge command sets the bank selected by pin A11 to the precharged state. This command can be executed at a time tRAS following the execution of an active command to the same bank. The selected bank goes to the idle state at a time tRP following the execution of the precharge command, and an active command can be executed again for that bank.

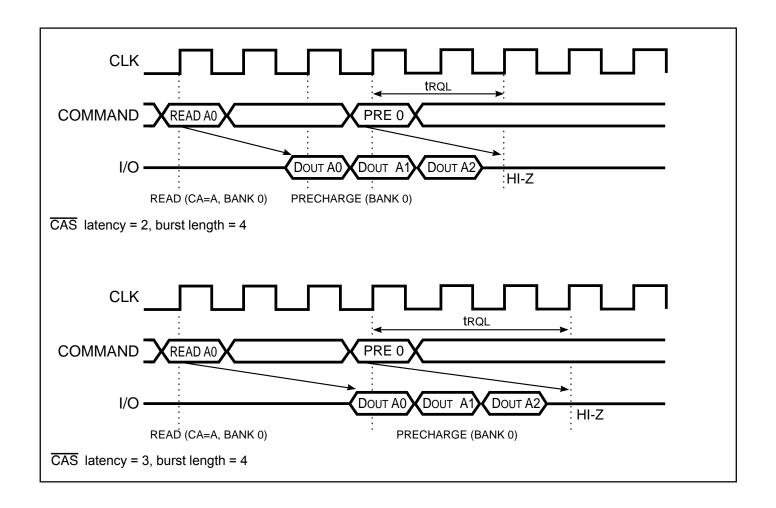
If pin A10 is low when this command is executed, the bank selected by pin A11 will be precharged, and if pin A10 is HIGH, both banks will be precharged at the same time. This input to pin A11 is ignored in the latter case.

Read Cycle Interruption

Using the Precharge Command

A read cycle can be interrupted by the execution of the precharge command before that cycle completes. The delay time (troc) from the execution of the precharge command to the completion of the burst output is the clock cycle of \overline{CAS} latency.

CAS Latency	3	2	
trql	3	2	





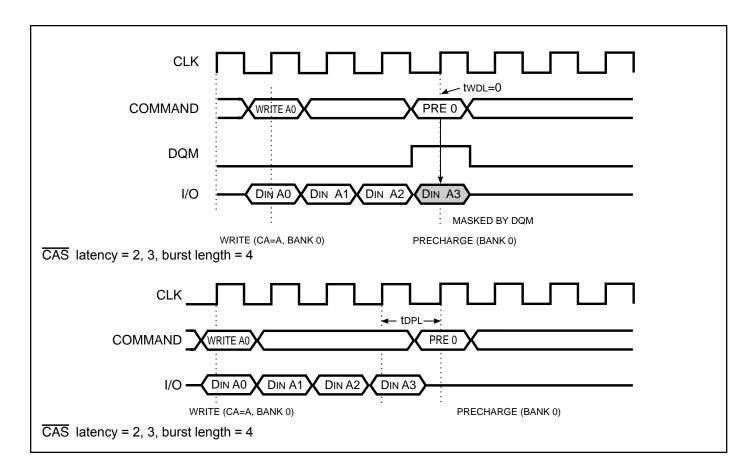
Write Cycle Interruption Using the Precharge Command

A write cycle can be interrupted by the execution of the precharge command before that cycle completes. The delay time (t_{WDL}) from the precharge command to the point where burst input is invalid, i.e., the point where input data is no longer written to device internal memory is zero clock cycles regardless of the CAS.

To inhibit invalid write, the DQM signal must be asserted HIGH with the precharge command.

This precharge command and burst write command must be of the same bank, otherwise it is not precharge interrupt but only another bank precharge of dual bank operation. Inversely, to write all the burst data to the device, the precharge command must be executed after the write data recovery period (tDPL) has elapsed. Therefore, the precharge command must be executed on one clock cycle that follows the input of the last burst data item.

CAS Latency	3	2	
twdl	0	0	
t DPL	1	1	



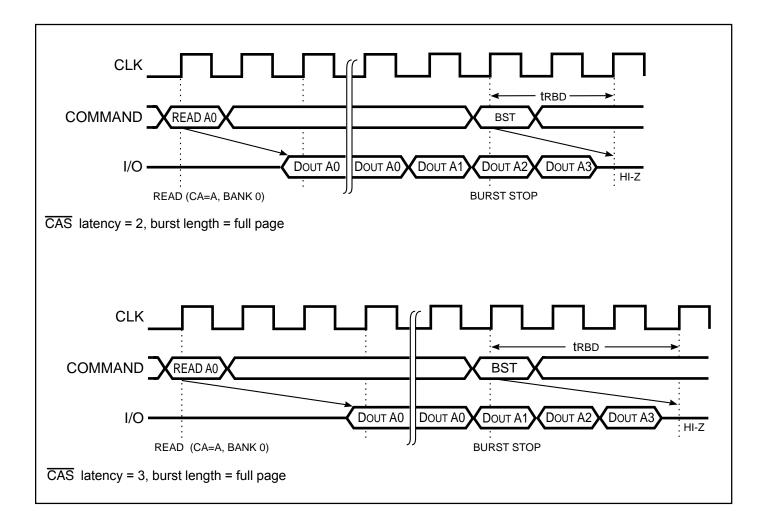


Read Cycle (Full Page) Interruption Using the Burst Stop Command

The IC42S16101 can output data continuously from the burst start address (a) to location a+255 during a read cycle in which the burst length is set to full page. The IC42S16101 repeats the operation starting at the 256th cycle with the data output returning to location (a) and continuing with a+1, a+2, a+3, etc. A burst stop command must be executed to terminate this cycle. A precharge command must be executed within the ACT to PRE command period (tRAS max.) following the burst stop command.

After the period (t_{RBD}) required for burst data output to stop following the execution of the burst stop command has elapsed, the outputs go to the HIGH impedance state. This period (t_{RBD}) is two clock cycle when the CAS latency is two and three clock cycle when the CAS latency is three.

CAS Latency	3	2
t RBD	3	2

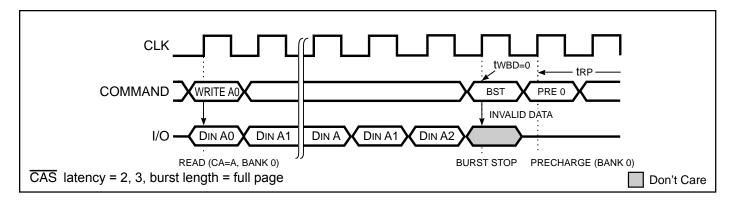




Write Cycle (Full Page) Interruption Using the Burst Stop Command

The IC42S16101 can input data continuously from the burst start address (a) to location a+255 during a write cycle in which the burst length is set to full page. The IC42S16101 repeats the operation starting at the 256th cycle with data input returning to location (a) and continuing with a+1, a+2, a+3, etc. A burst stop command must be executed to terminate this cycle. A precharge command

must be executed within the ACT to PRE command period (t_{RAS} max.) following the burst stop command. After the period (t_{WBD}) required for burst data input to stop following the execution of the burst stop command has elapsed, the write cycle terminates. This period (t_{WBD}) is zero clock cycles, regardless of the \overline{CAS} latency.

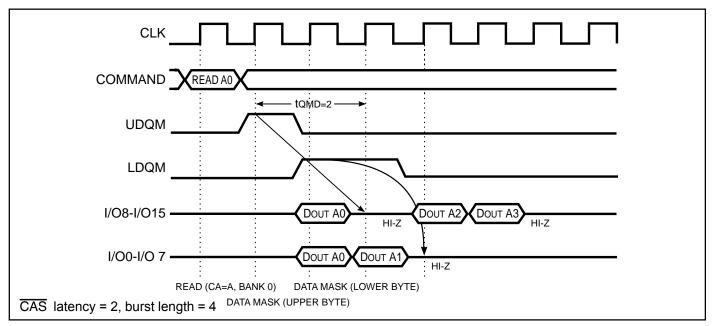


Burst Data Interruption Using the

U/LDQM Pins (Read Cycle)

Burst data output can be temporarily interrupted (masked) during a read cycle using the U/LDQM pins. Regardless of the CAS latency, two clock cycles (tqMD) after one of the U/ LDQM pins goes HIGH, the corresponding outputs go to the HIGH impedance state. Subsequently, the outputs are maintained in the high impedance state as long as that U/ LDQM pin remains HIGH. When the U/LDQM pin goes LOW, output is resumed at a time tome later. This output control operates independently on a byte basis with the UDQM pin controlling upper byte output (pins I/O8-I/O15) and the LDQM pin controlling lower byte output (pins I/O0 to I/O7).

Since the U/LDQM pins control the device output buffers only, the read cycle continues internally and, in particular, incrementing of the internal burst counter continues.



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Burst Data Interruption U/LDQM Pins

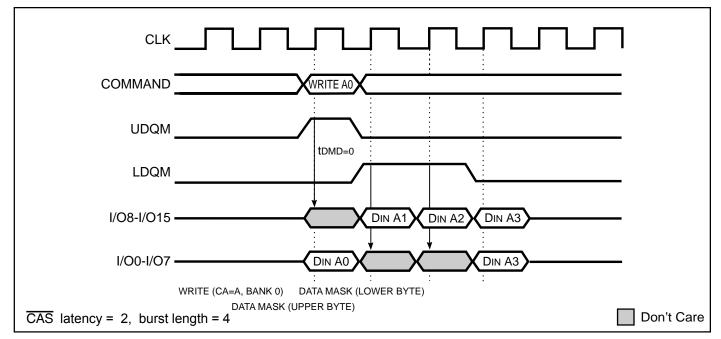
(Write Cycle)

Burst data input can be temporarily interrupted (muted) during a write cycle using the U/LDQM pins. Regardless of the CAS latency, as soon as one of the U/LDQM pins goes HIGH, the corresponding externally applied input data will no longer be written to the device internal circuits. Subsequently, the corresponding input continues to be muted as long as that U/LDQM pin remains HIGH.

The IC42S16101 will revert to accepting input as soon as

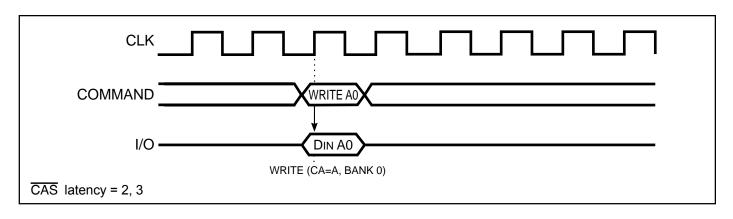
that pin is dropped to LOW and data will be written to the device. This input control operates independently on a byte basis with the UDQM pin controlling upper byte input (pin I/O8 to I/O15) and the LDQM pin controlling the lower byte input (pins I/O0 to I/O7).

Since the U/LDQM pins control the device input buffers only, the cycle continues internally and, inparticular, incrementing of the internal burst counter continues.



Burst Read and Single Write

The burst read and single write mode is set up using the mode register set command. During this operation, the burst read cycle operates normally, but the write cycle only writes a single data item for each write cycle. The CAS latency and DQM latency are the same as in normal mode.

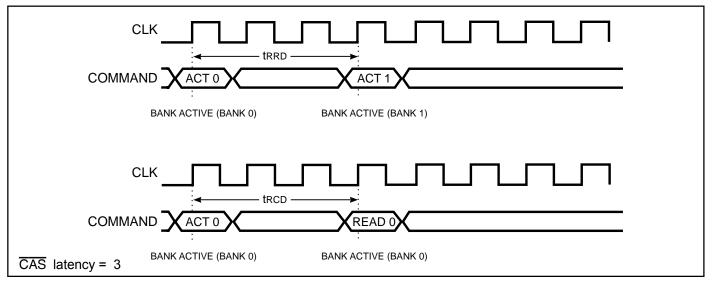




Bank Active Command Interval

When the selected bank is precharged, the period trp has elapsed and the bank has entered the idle state, the bank can be activated by executing the active command. If the other bank is in the idle state at that time, the active command can be executed for that bank after the period tRRD has elapsed. At that point both banks will be in the active state. When a bank active command has been executed, a precharge command must be executed for that bank within the ACT to PRE command period (tras max). Also note that a precharge command cannot be executed for an active bank before tras (min) has elapsed.

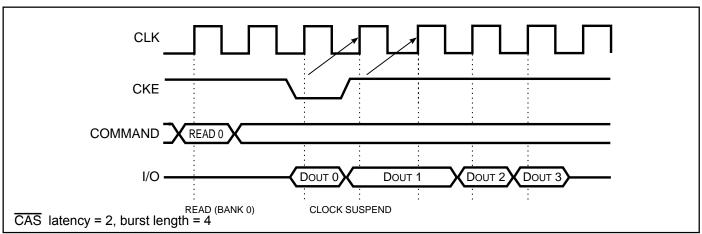
After a bank active command has been executed and the trcd period has elapsed, read write (including autoprecharge) commands can be executed for that bank.



Clock Suspend

When the CKE pin is dropped from HIGH to LOW during a read or write cycle, the IS42S16101 enters clock suspend mode on the next CLK rising edge. This command reduces the device power dissipation by stopping the device internal clock. Clock suspend mode continues as long as the CKE pin remains low. In this state, all inputs other than CKE pin are invalid and no other commands can be executed. Also, the device internal states are maintained. When the CKE pin goes from LOW to HIGH clock suspend mode is terminated on the next CLK rising edge and device operation resumes. The next command cannot be executed until the recovery period (tcka) has elapsed.

Since this command differs from the self-refresh command described previously in that the refresh operation is not performed automatically internally, the refresh operation must be performed within the refresh period (tref). Thus the maximum time that clock suspend mode can be held is just under the refresh cycle time.

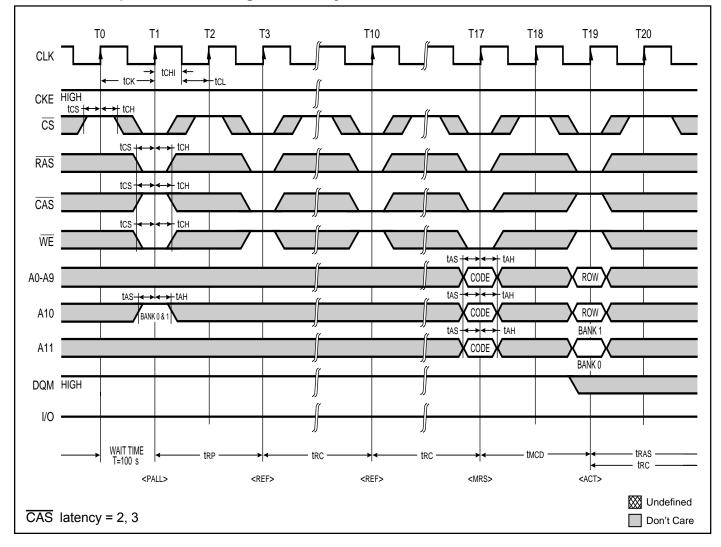


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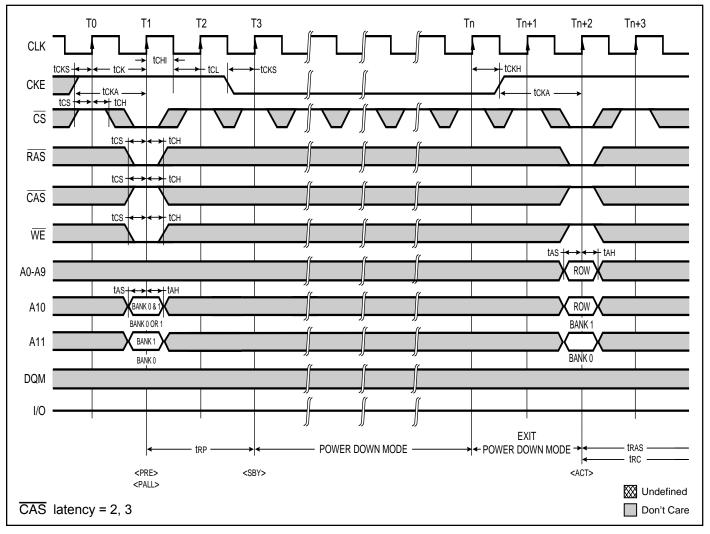
OPERATION TIMING EXAMPLE

Power-On Sequence, Mode Register Set Cycle



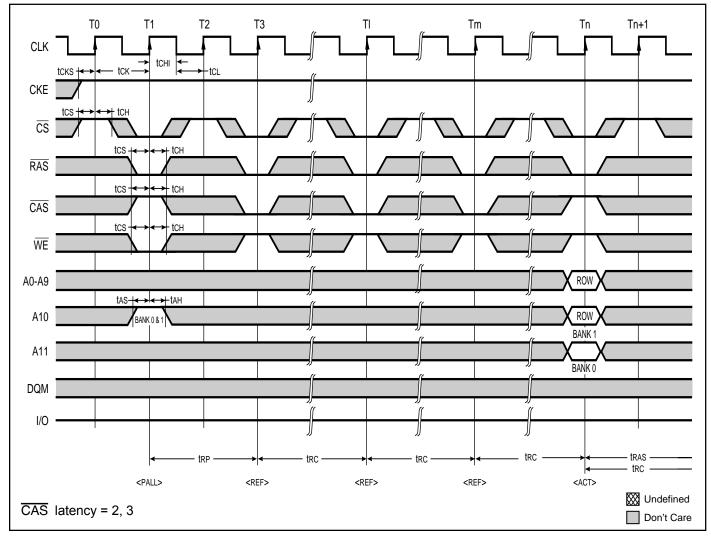


Power-Down Mode Cycle



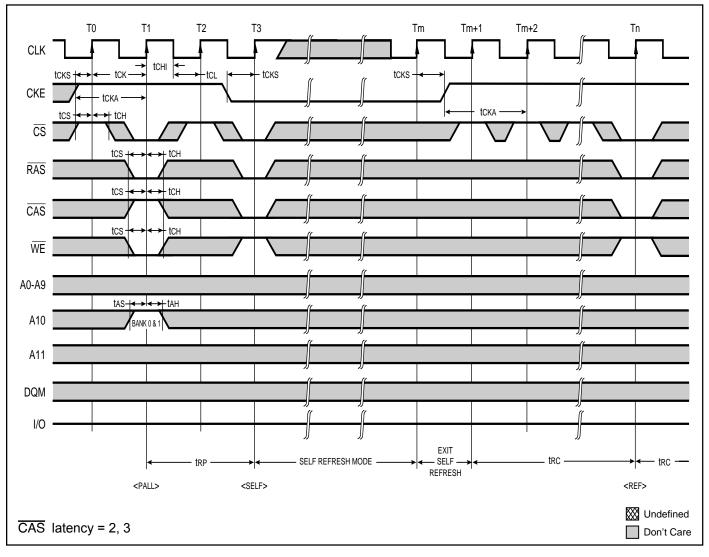


Auto-Refresh Cycle





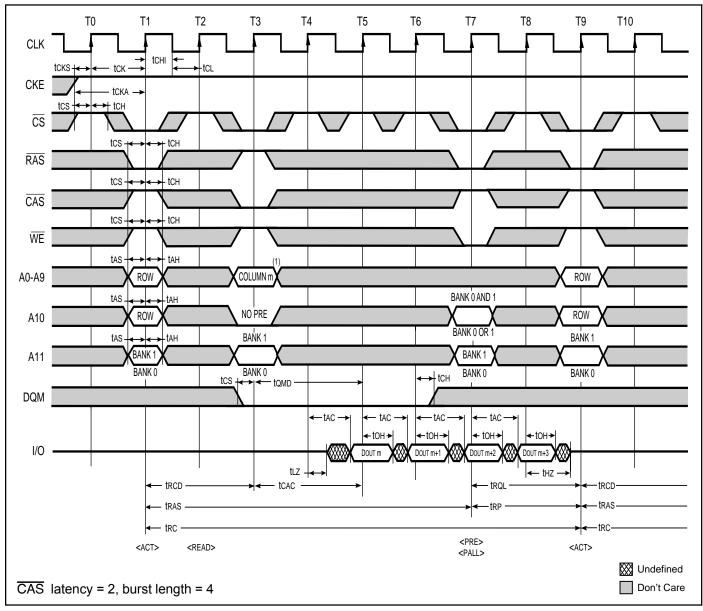
Self-Refresh Cycle



IC42S16101

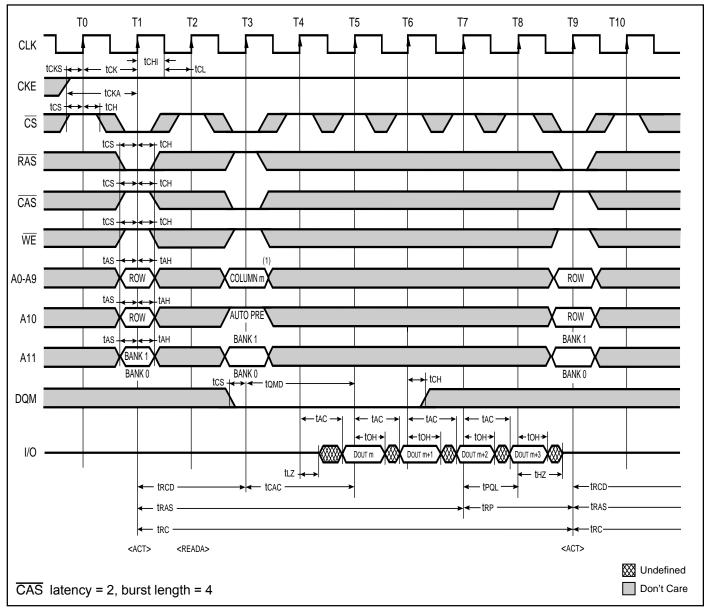


Read Cycle



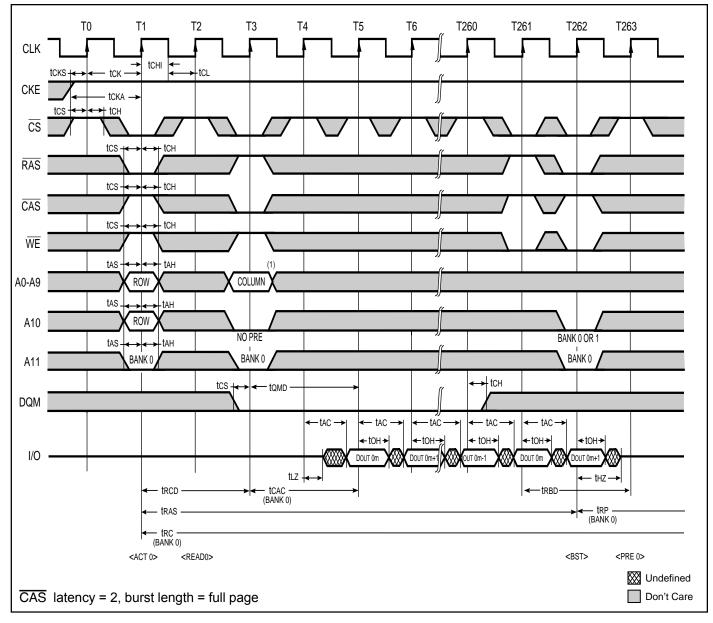


Read Cycle / Auto-Precharge

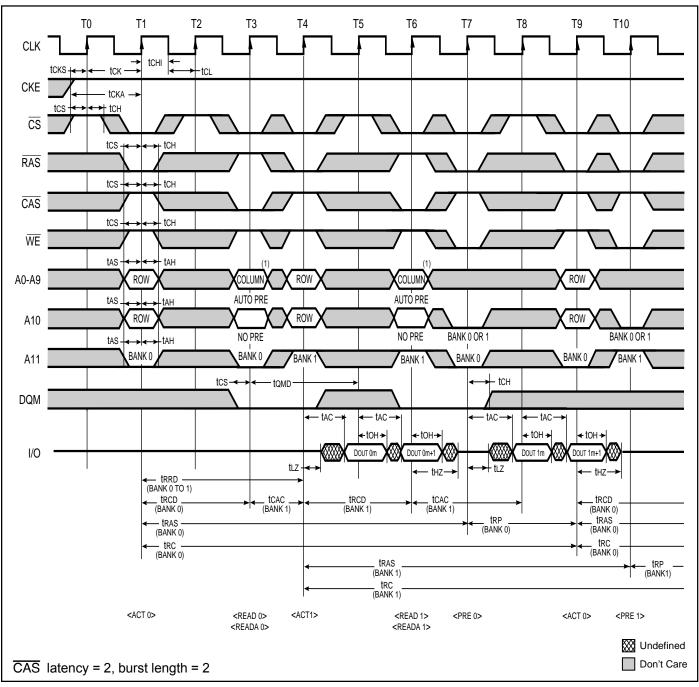




Read Cycle / Full Page



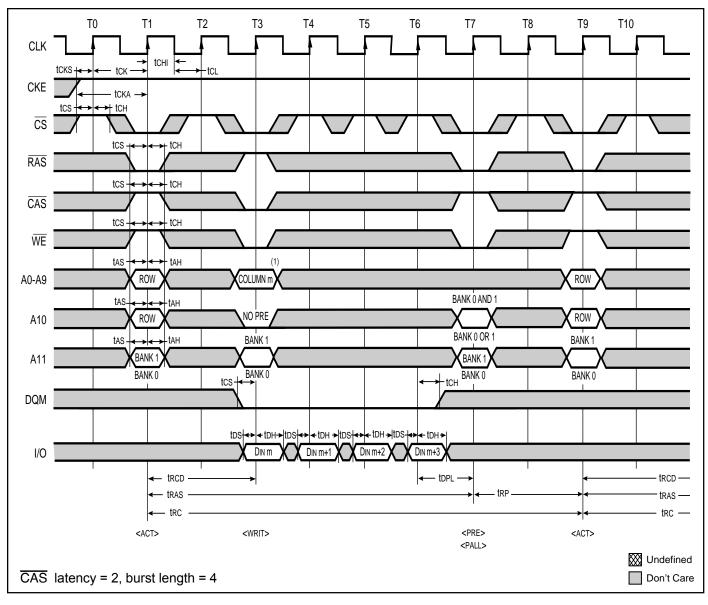




Read Cycle / Ping-Pong Operation (Bank Switching)

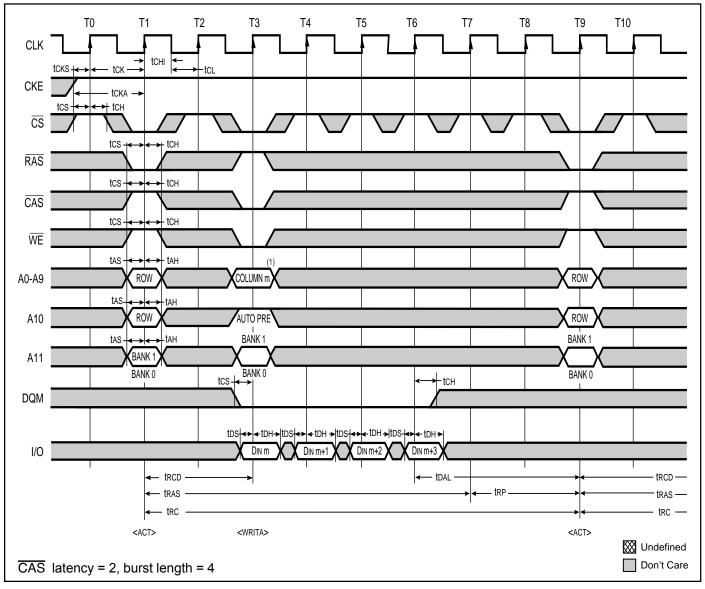


Write Cycle



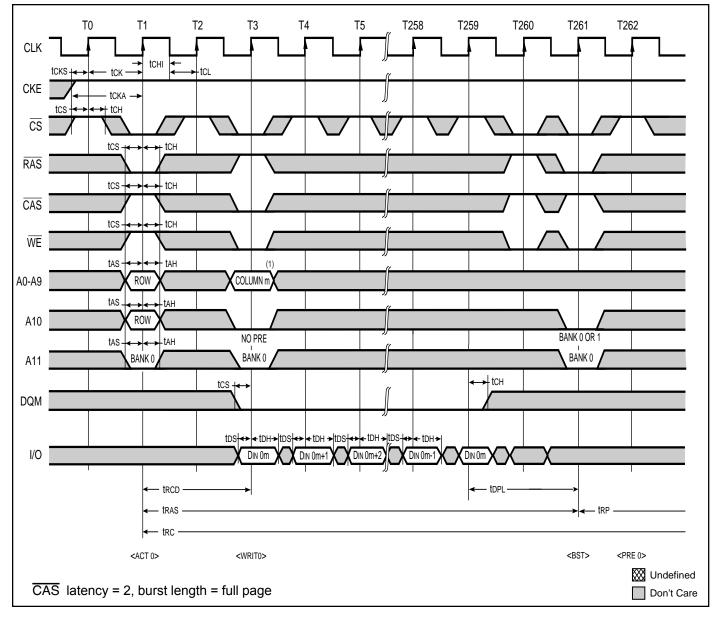


Write Cycle / Auto-Precharge



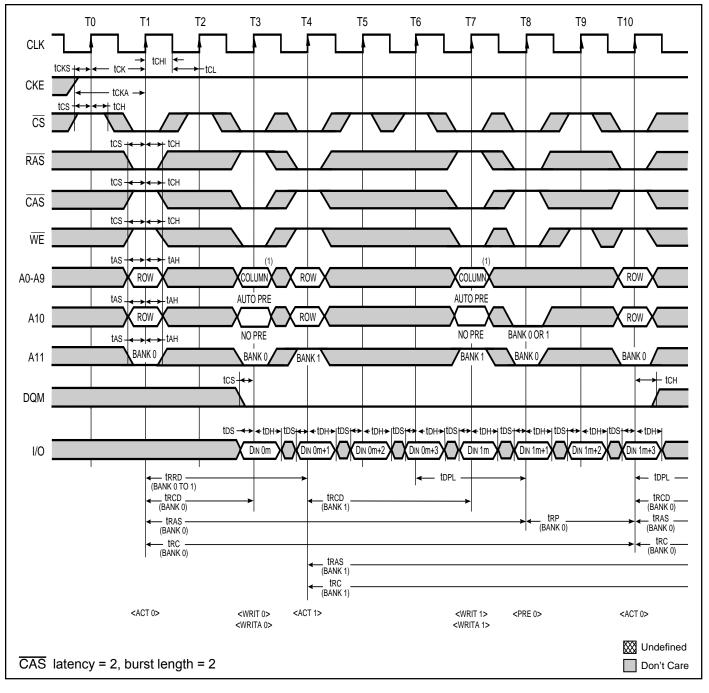


Write Cycle / Full Page



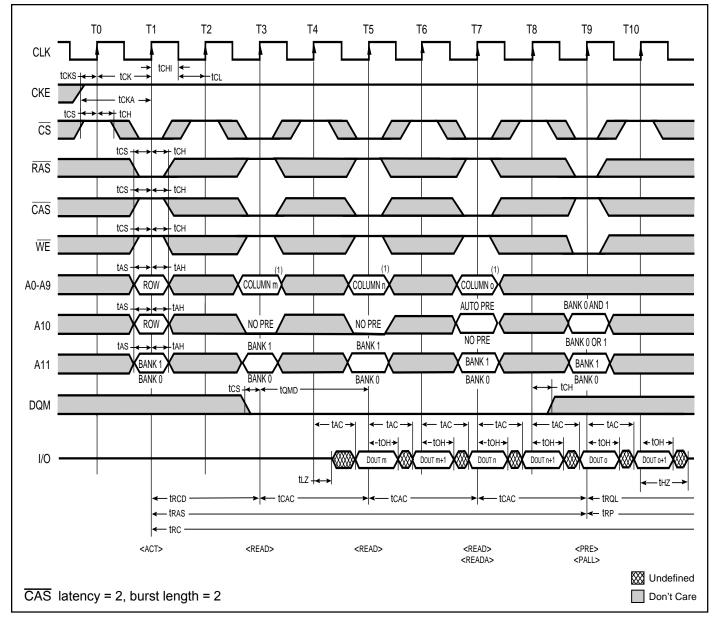


Write Cycle / Ping-Pong Operation



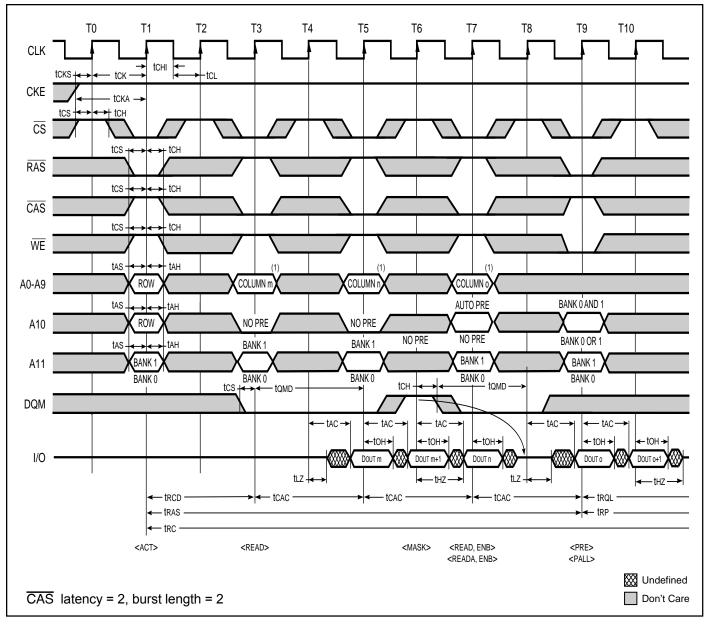


Read Cycle / Page Mode



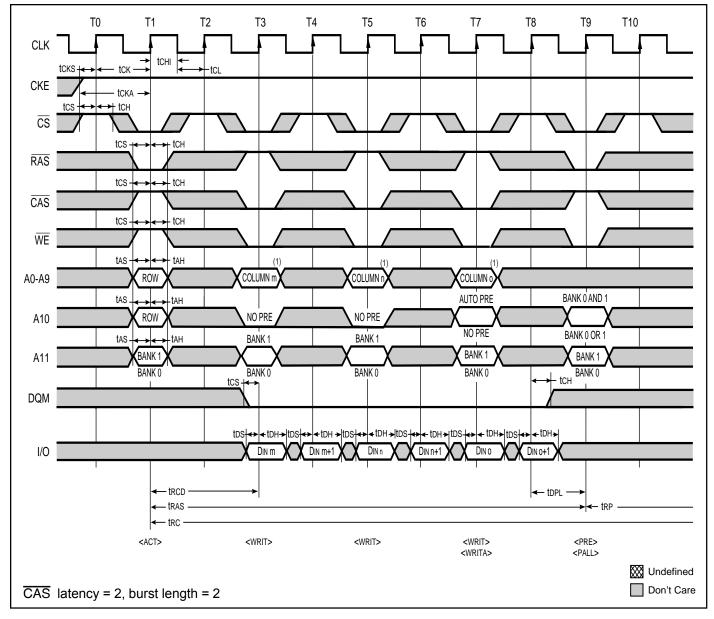


Read Cycle / Page Mode; Data Masking



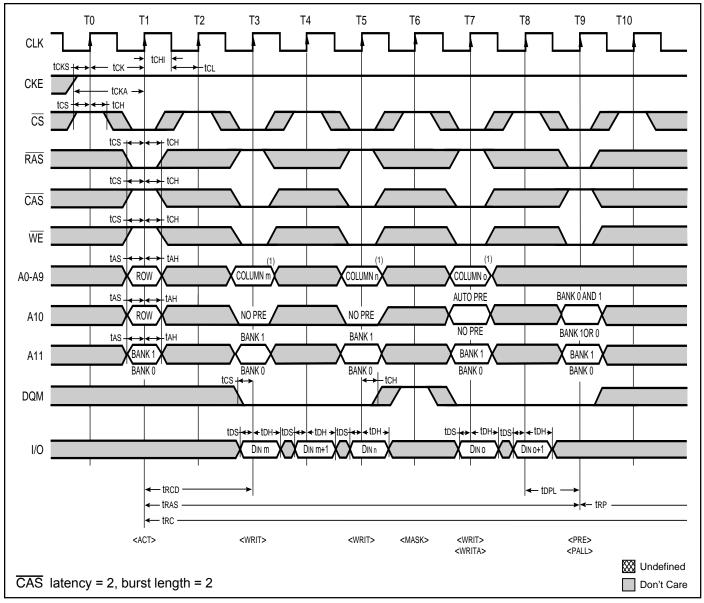


Write Cycle / Page Mode



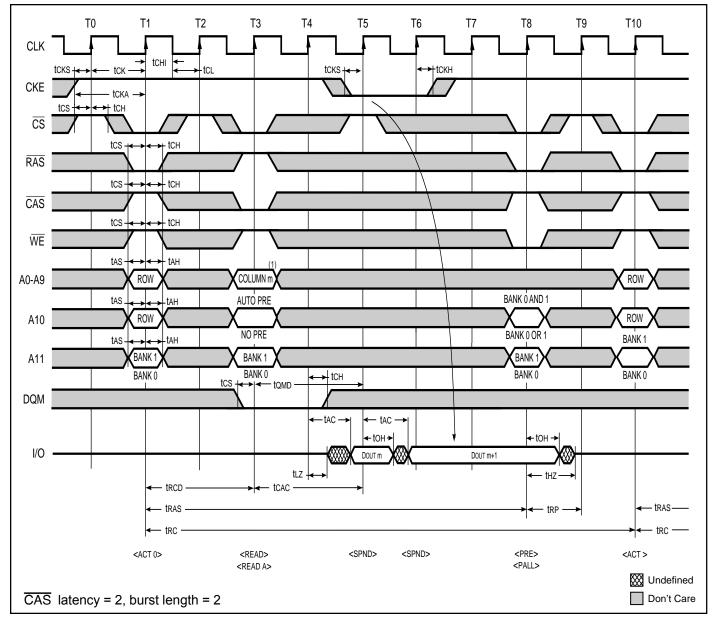






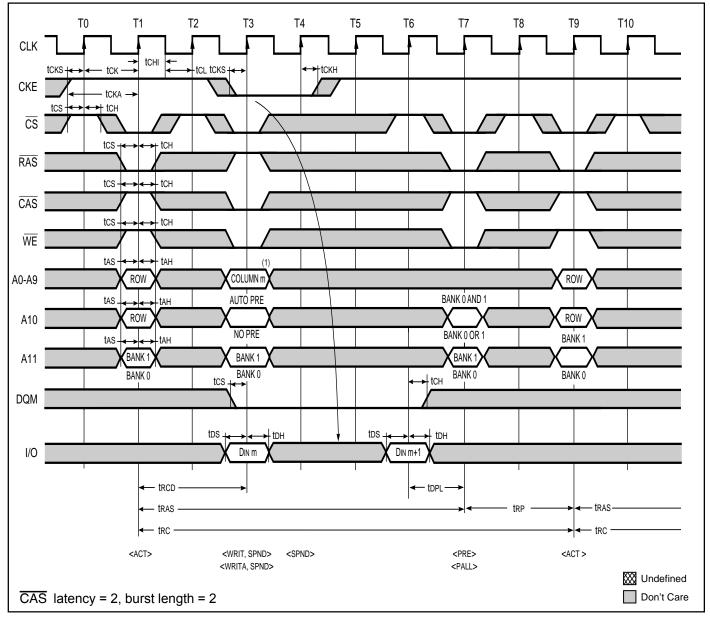


Read Cycle / Clock Suspend



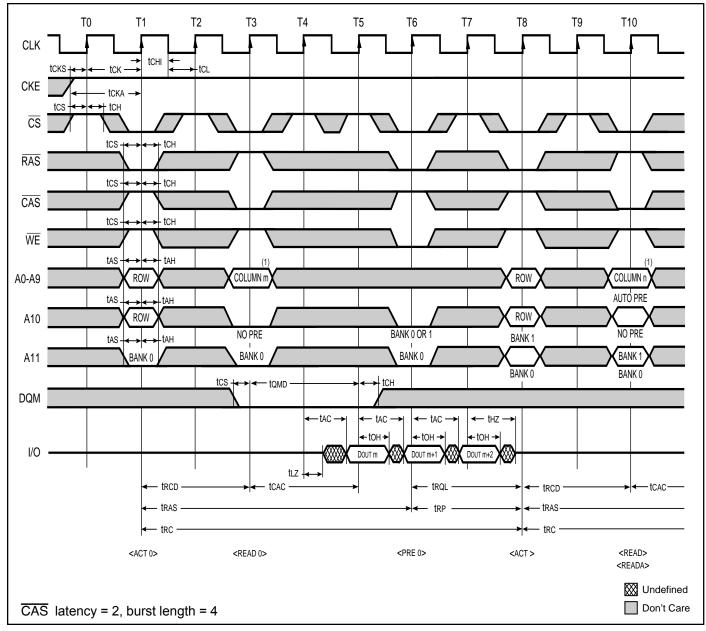


Write Cycle / Clock Suspend



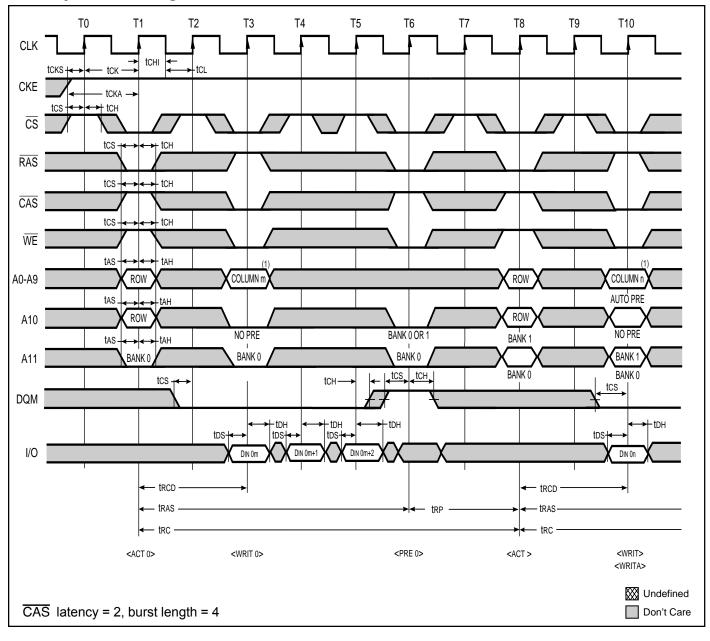






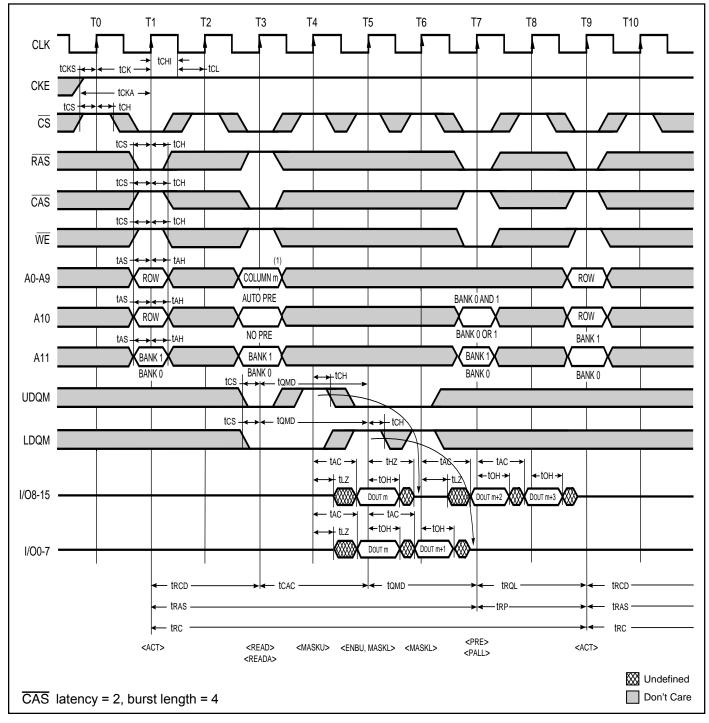


Write Cycle / Precharge Termination



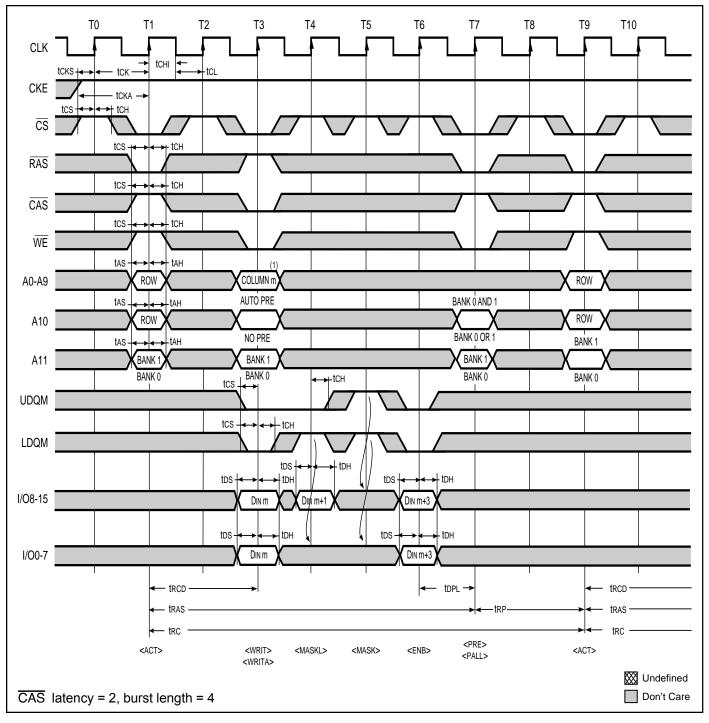


Read Cycle / Byte Operation



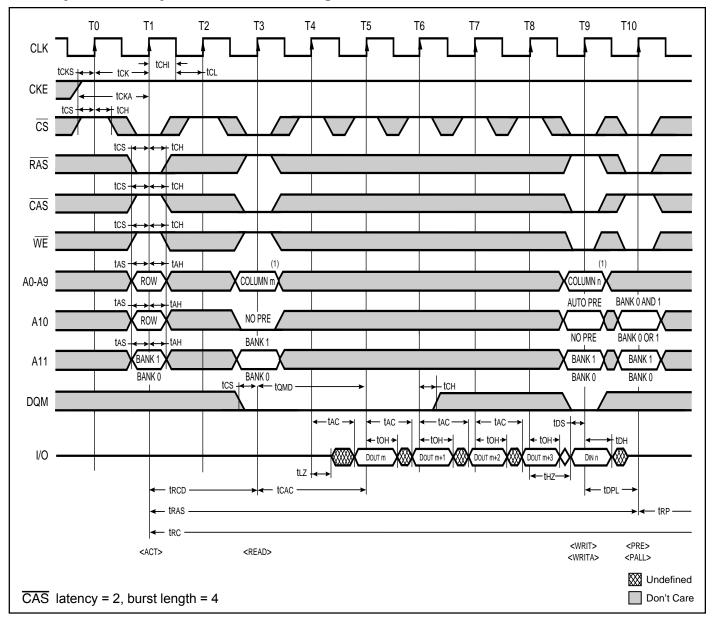


Write Cycle / Byte Operation



Note 1: A8,A9 = Don't Care.

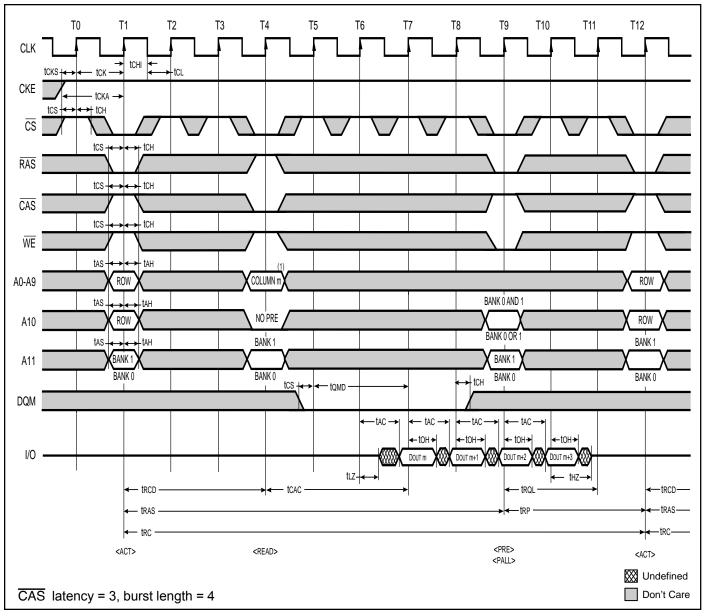




Read Cycle, Write Cycle / Burst Read, Single Write

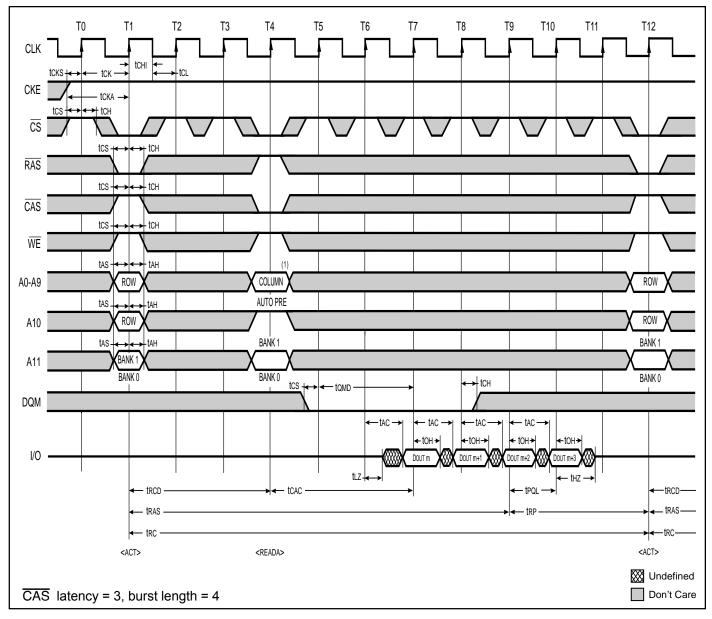


Read Cycle



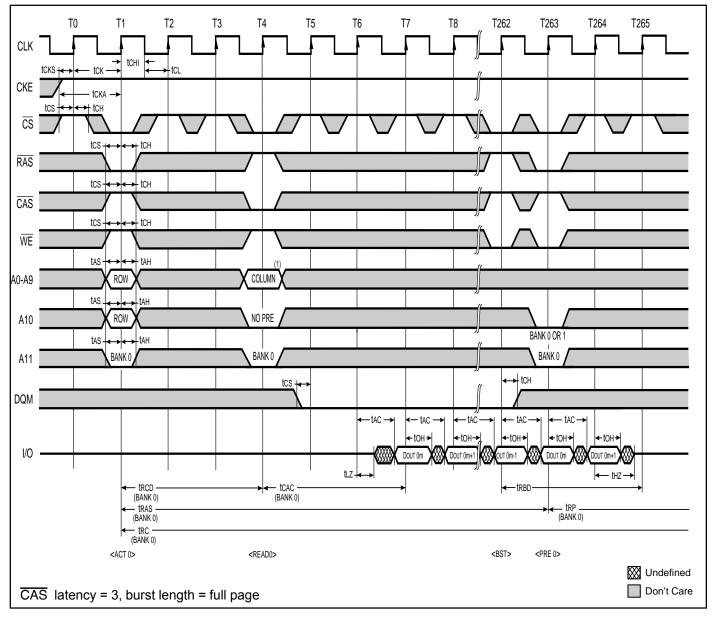


Read Cycle / Auto-Precharge

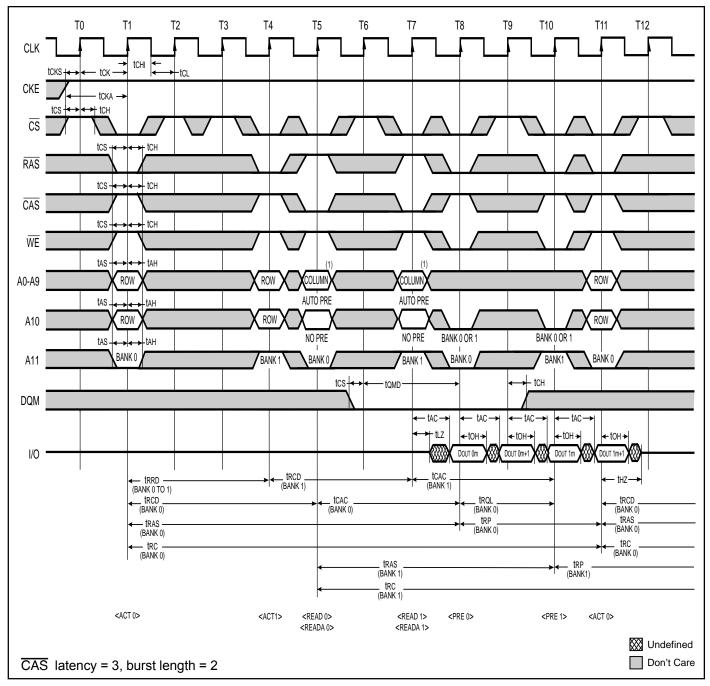




Read Cycle / Full Page



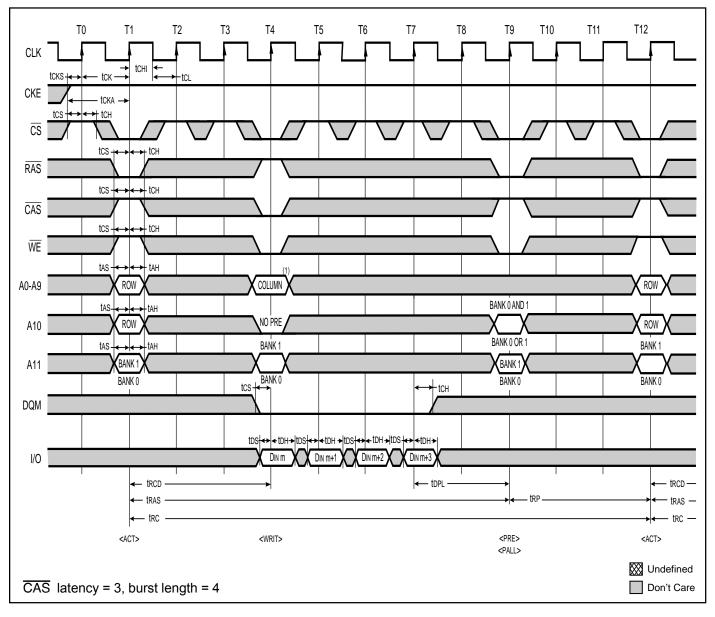




Read Cycle / Ping Pong Operation (Bank Switching)

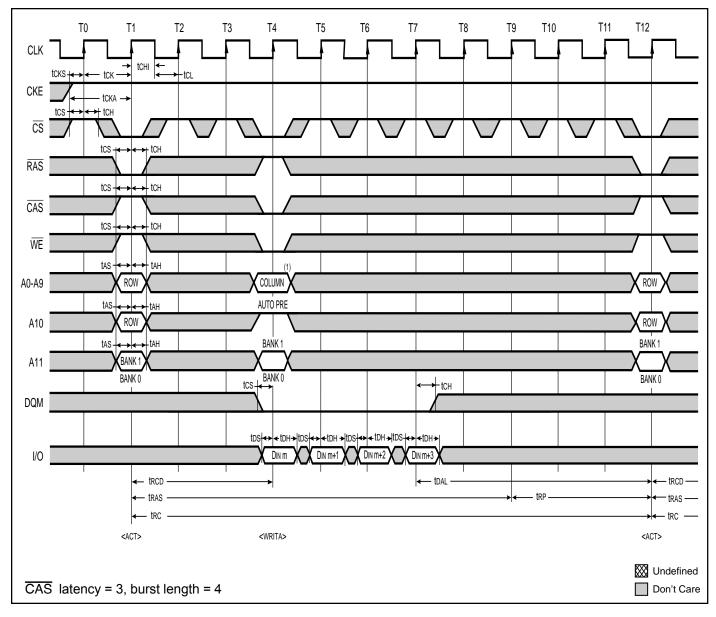


Write Cycle



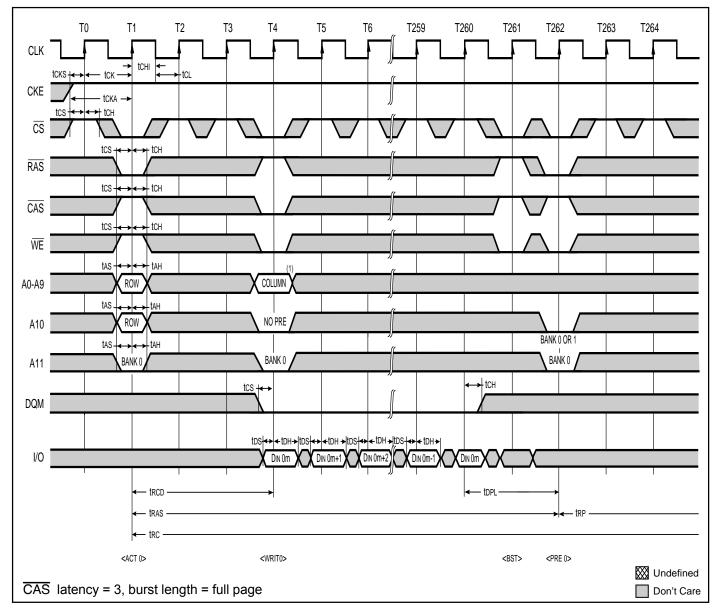


Write Cycle / Auto-Precharge

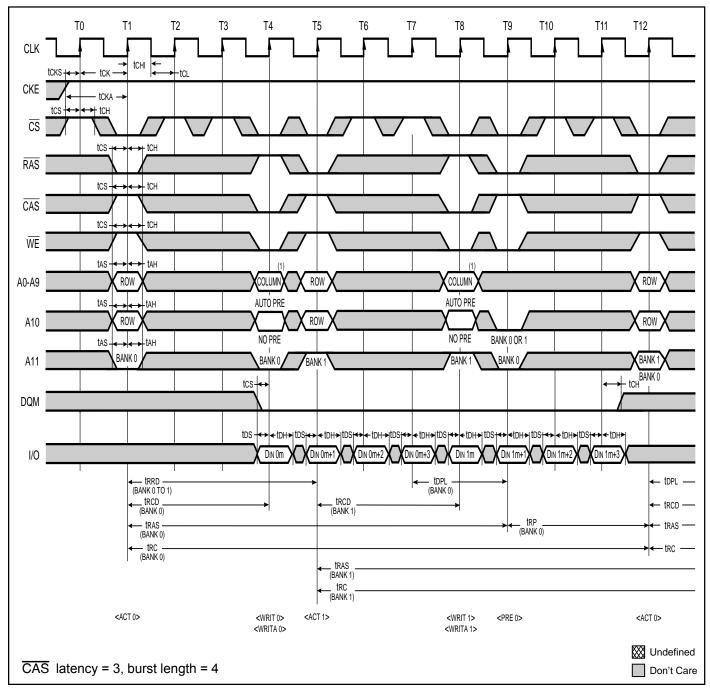




Write Cycle / Full Page



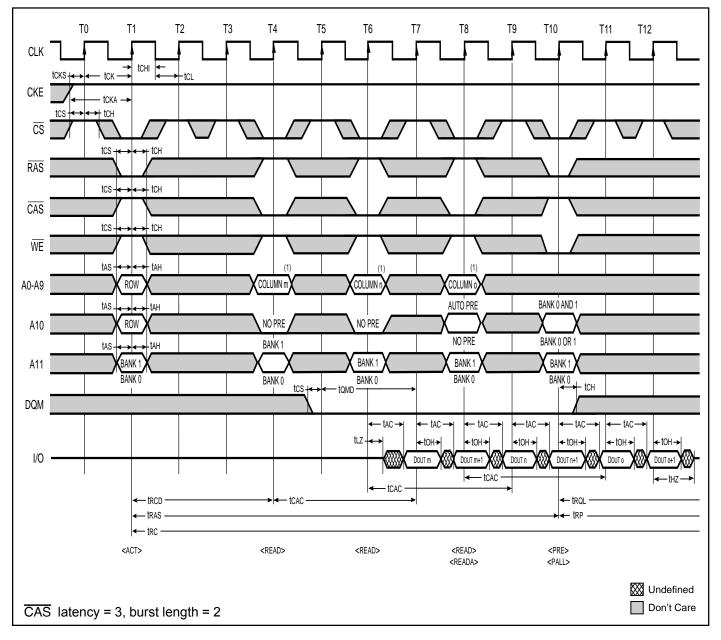




Write Cycle / Ping-Pong Operation (Bank Switching)

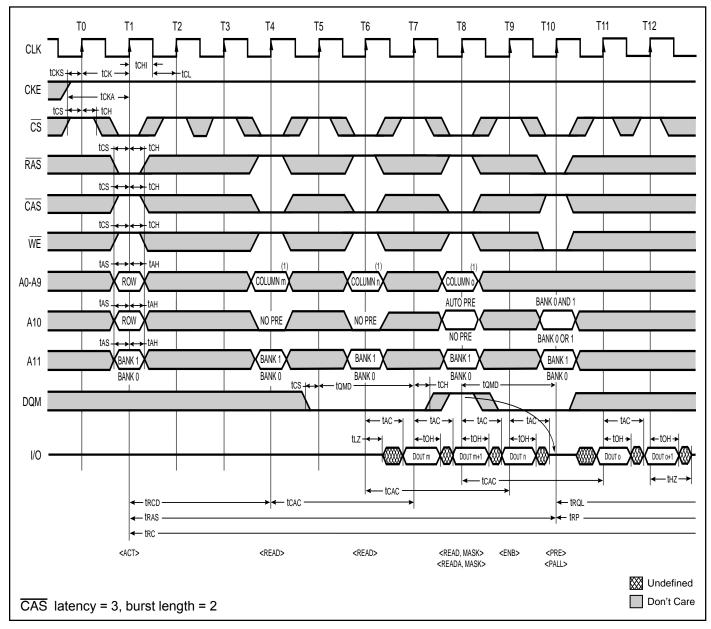


Read Cycle / Page Mode



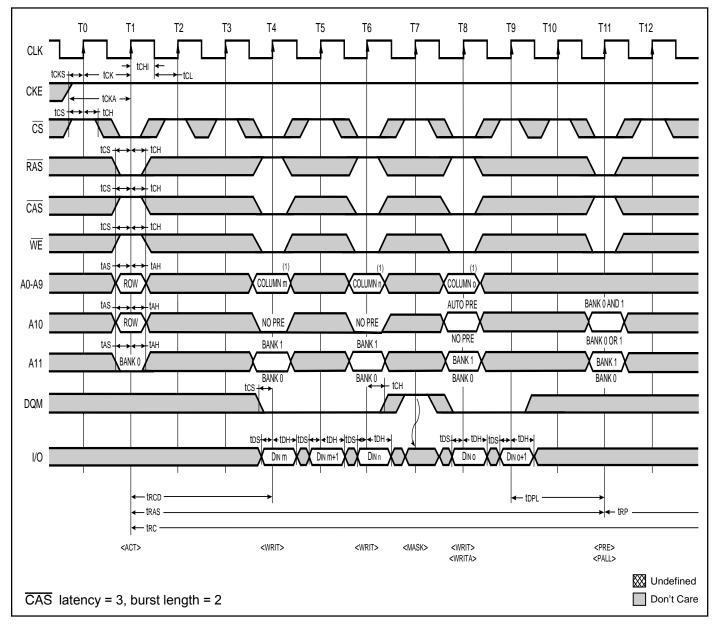






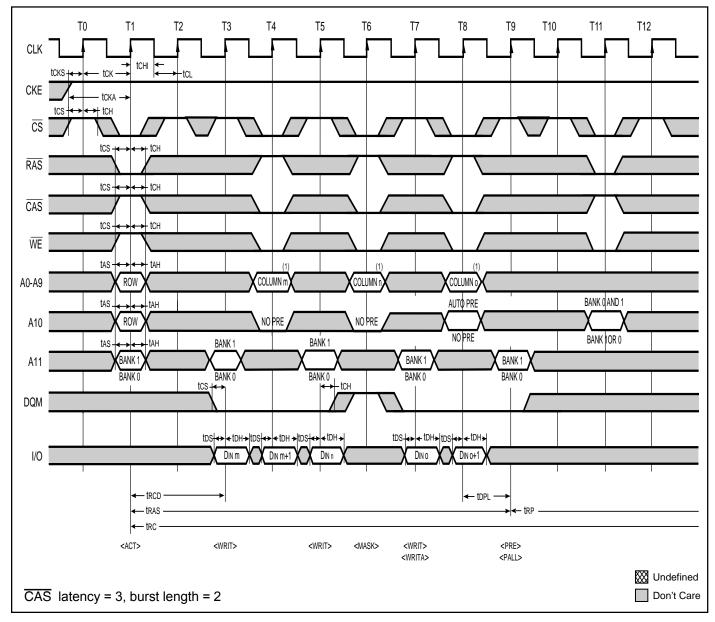


Write Cycle / Page Mode



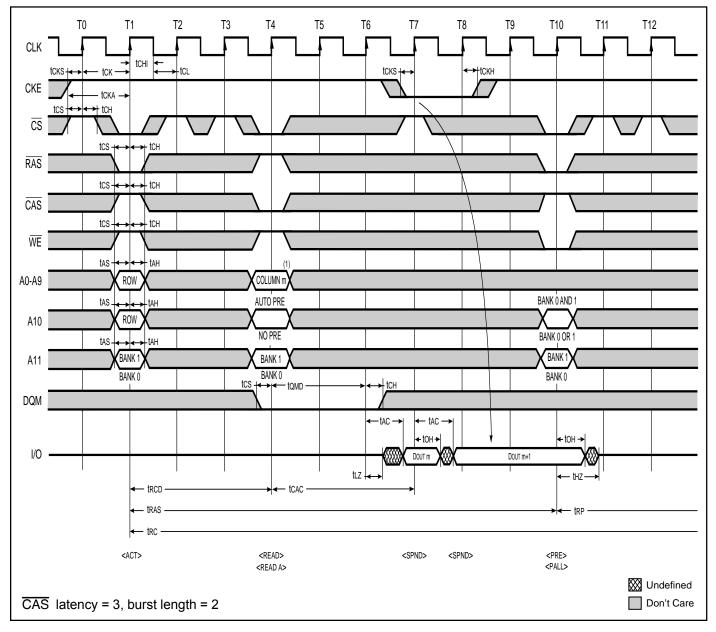






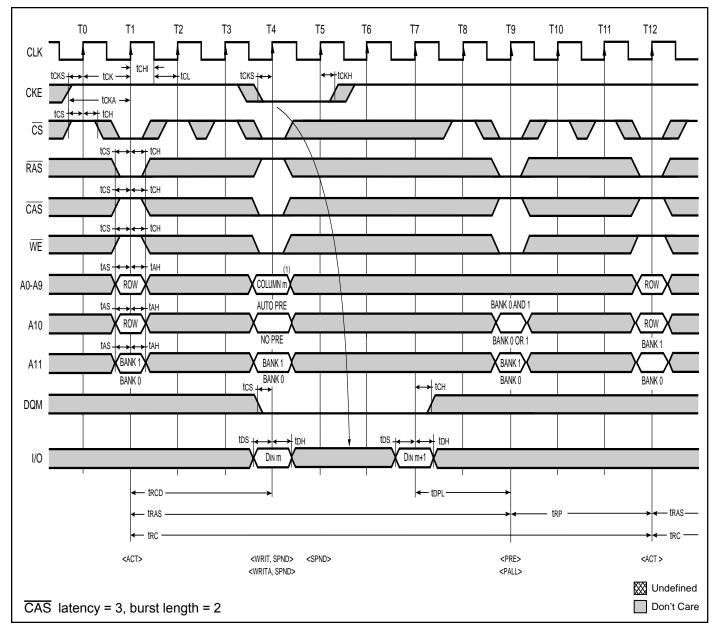


Read Cycle / Clock Suspend



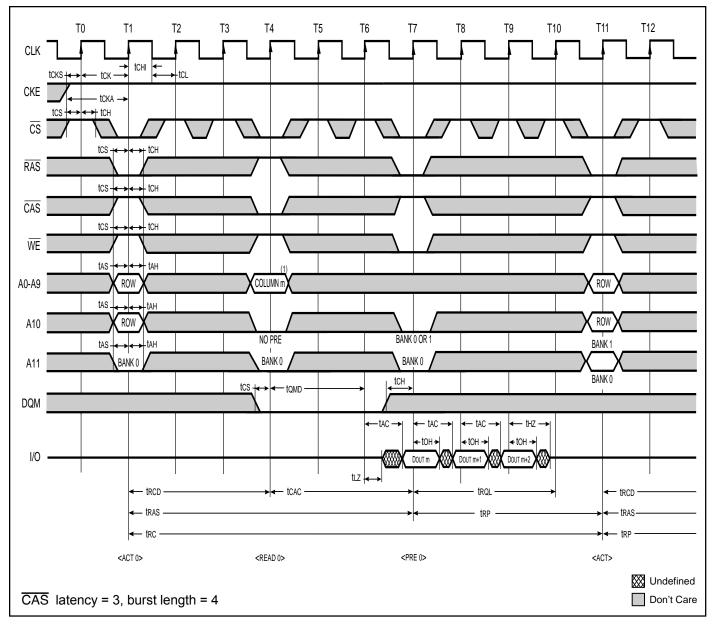


Write Cycle / Clock Suspend



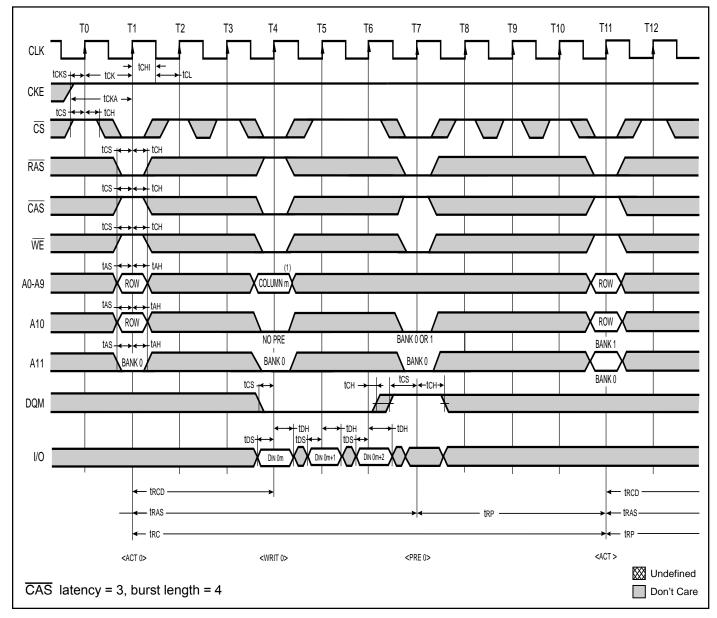






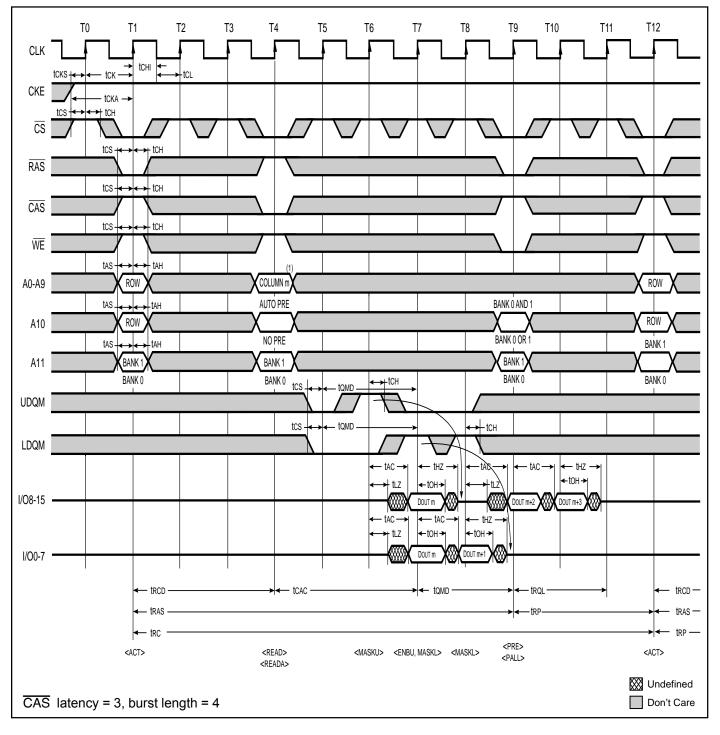






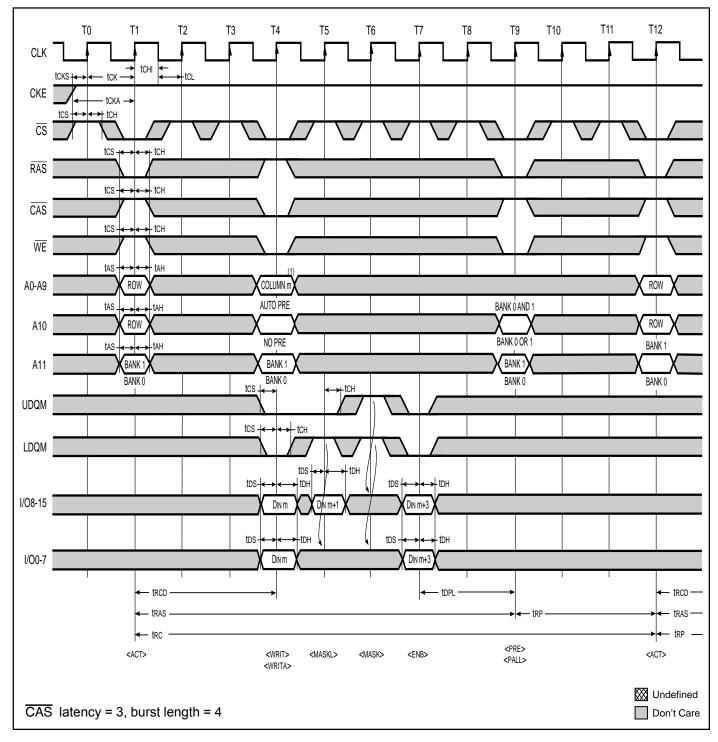


Read Cycle / Byte Operation

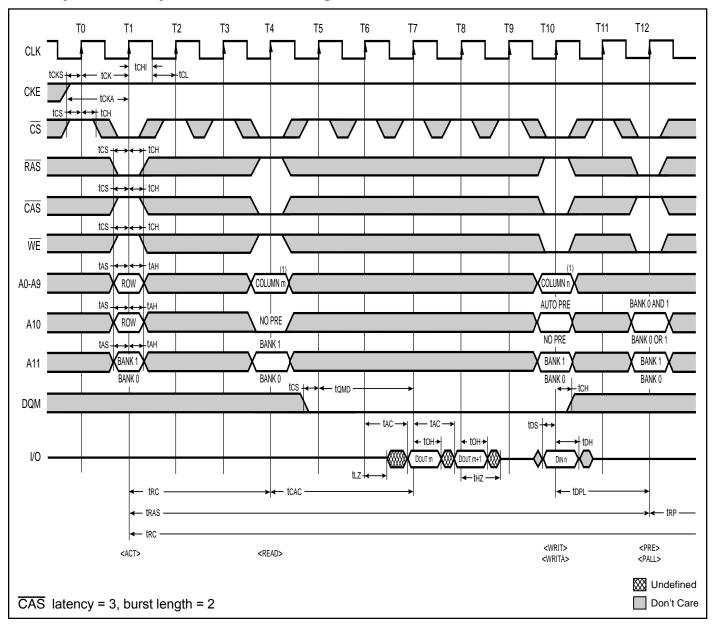




Write Cycle / Byte Operation







Read Cycle, Write Cycle / Burst Read, Single Write



ORDERING INFORMATION Commercial Range: 0°C to 70°C

Frequency	Speed (ns)	Order Part No.	Package
200MHz	5	IC42S16101-5T	400mil TSOP-2
		IC42S16101-5TG	400mil TSOP-2(Pb-free)
		IC42S16101-5BG	60Ball VF-BGA(Pb-free)
166MHz	6	IC42S16101-6T	400mil TSOP-2
		IC42S16101-6TG	400mil TSOP-2(Pb-free)
		IC42S16101-6BG	60Ball VF-BGA(Pb-free)
143MHz	7	IC42S16101-7T	400mil TSOP-2
		IC42S16101-7TG	400mil TSOP-2(Pb-free)
		IC42S16101-7BG	60Ball VF-BGA(Pb-free)

ORDERING INFORMATION

Industrial Temperature Range: -40°C to 85°C

Frequency	Speed (ns)	Order Part No.	Package
200MHz	5	IC42S16101-5TI	400mil TSOP-2
		IC42S16101-5TIG	400mil TSOP-2(Pb-free)
		IC42S16101-5BIG	60Ball VF-BGA(Pb-free)
166MHz	6	IC42S16101-6TI	400mil TSOP-2
		IC42S16101-6TIG	400mil TSOP-2(Pb-free)
		IC42S16101-6BIG	60Ball VF-BGA(Pb-free)
143MHz	7	IC42S16101-7TI	400mil TSOP-2
		IC42S16101-7TIG	400mil TSOP-2(Pb-free)
		IC42S16101-7BIG	60Ball VF-BGA(Pb-free)



Integrated Circuit Solution Inc.

HEADQUARTER: NO.2, TECHNOLOGY RD. V, SCIENCE-BASED INDUSTRIAL PARK, HSIN-CHU, TAIWAN, R.O.C. TEL: 886-3-5780333 Fax: 886-3-5783000

> BRANCH OFFICE: 7F, NO. 106, SEC. 1, HSIN-TAI 5TH ROAD, HSICHIH TAIPEI COUNTY, TAIWAN, R.O.C. TEL: 886-2-26962140 FAX: 886-2-26962252 http://www.icsi.com.tw